

# Tektronix

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## Automotive Ethernet 최신동향과 스펙/Tektronix 테스트 solution

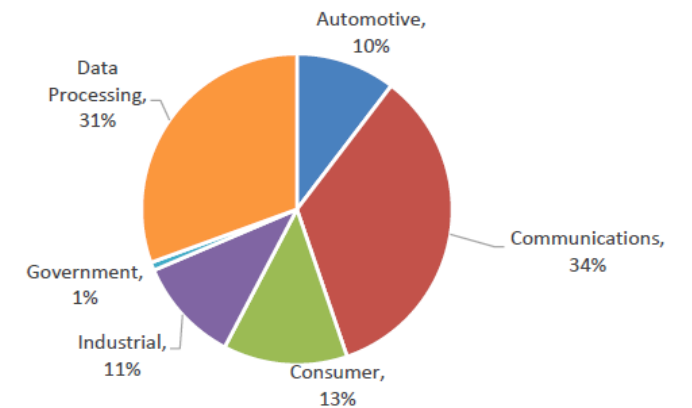
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OCT 2018 이기응



# Automotive Micro Drivers

- Safety
  - Airbags, TPMS, Backup camera
  - NHTSA sets initiatives (\$4B over 19 years) to accelerate ADAS
- Fuel economy
  - Japan sets light commercial vehicle fuel standard to increase fuel economy by 26%
  - U.S. sets fuel-economy goals of 54.5 MPG by 2025
- Emissions
  - U.S. sets 45–50 % reduction in CO2 emissions per mile by 2025
  - Germany has pledged to cut carbon dioxide emissions by 80 to 95 percent by 2050
- Social & customer needs
  - Connected car
  - UBER, ZIP CAR, BMW Drivenow



Source: WSTS 2014

# Automotive Applications

Autonomous Car	Telematics	Infotainment	In-vehicle network	Powertrain	Sensors	Body and Comfort
<ul style="list-style-type: none"> <li>• L0 to L5</li> <li>• Rear/front/side cameras</li> <li>• Blind spot detection</li> <li>• Auto parking</li> <li>• V2V/V2I</li> </ul>	<ul style="list-style-type: none"> <li>• Cellular</li> <li>• V2X</li> <li>• GPS</li> <li>• WiFi</li> <li>• Bluetooth</li> <li>• NFC</li> </ul>	<ul style="list-style-type: none"> <li>• Navigation systems</li> <li>• Audio/video entertainment</li> <li>• HMI (touch, voice, haptic)</li> <li>• Heads-up display</li> <li>• Hands-free phone</li> </ul>	<ul style="list-style-type: none"> <li>• Automotive control busses enable communication between ECUs, sensors, actuators, etc</li> </ul>	<ul style="list-style-type: none"> <li>• Fuel delivery</li> <li>• Engine management</li> <li>• Emission controls</li> <li>• Electronic steering</li> <li>• Electronic braking</li> <li>• Transmission controls</li> <li>• Active suspension</li> <li>• Battery systems</li> <li>• Motors (hybrid/ electric)</li> <li>• Wireless Charging</li> </ul>	<ul style="list-style-type: none"> <li>• Air Bags</li> <li>• Electronic stability control</li> <li>• Tire pressure monitoring</li> <li>• Adaptive cruise control</li> <li>• Blind spot warning</li> <li>• Auto braking</li> <li>• Multiple Sensors</li> <li>• Sensor Nano Technology</li> </ul>	<ul style="list-style-type: none"> <li>• Door</li> <li>• Window</li> <li>• Lighting</li> <li>• TPMS</li> <li>• RKE</li> <li>• Adaptive lighting</li> </ul>
Radar + Camera+ Lidar+CPU+DDR4 +Flash+PCIe + Network standards	5G, LTE, HSPA, GSM, CDMA, 802.11AD	CPU+DDR4/LPD DR4+PCI+Flash+ HDMI+I2S+USB +SATA/SAS	CAN, LIN, FlexRay, SENT, CXPI, PSI5, 100/1000BASE-T1, FPD-Link, HD-BASET	WGB component, Battery, Invertor-Converter, Motor, Battery charging, Power Efficiency Testing	Component Testing, ECU Testing	LED component Test, Keyless Protocol Testing

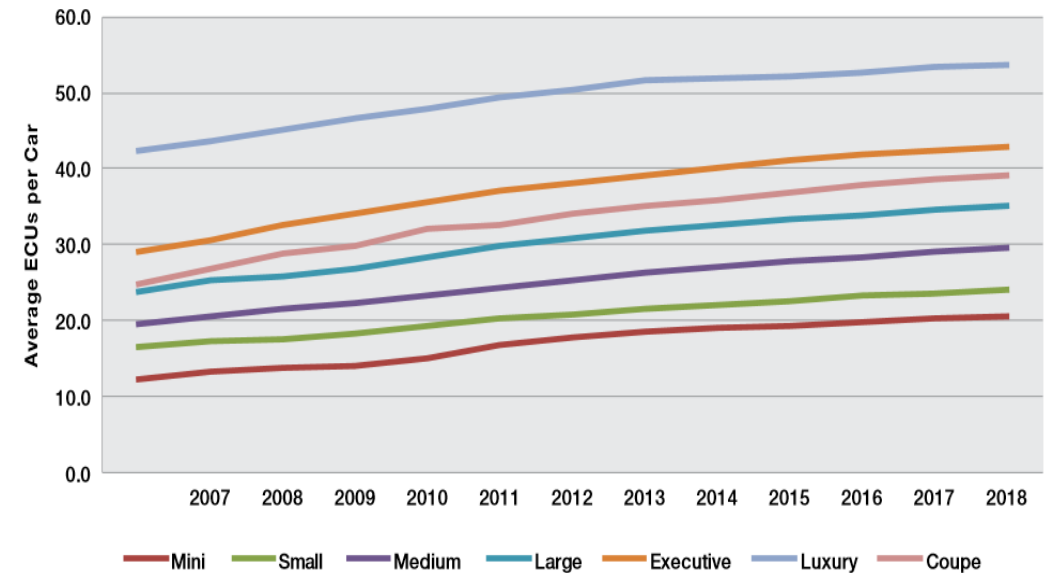
# In-Vehicle Network Standards

Industry trends

# In-Vehicle Network

## NETWORKS ON WHEELS

- ECUs communicate with each other over In-Vehicle Network (IVN)
- On Average there are 30-40 ECUs in luxury car
- Each ECU have at least one IVN node
- Typically 60-80 IVN nodes per car

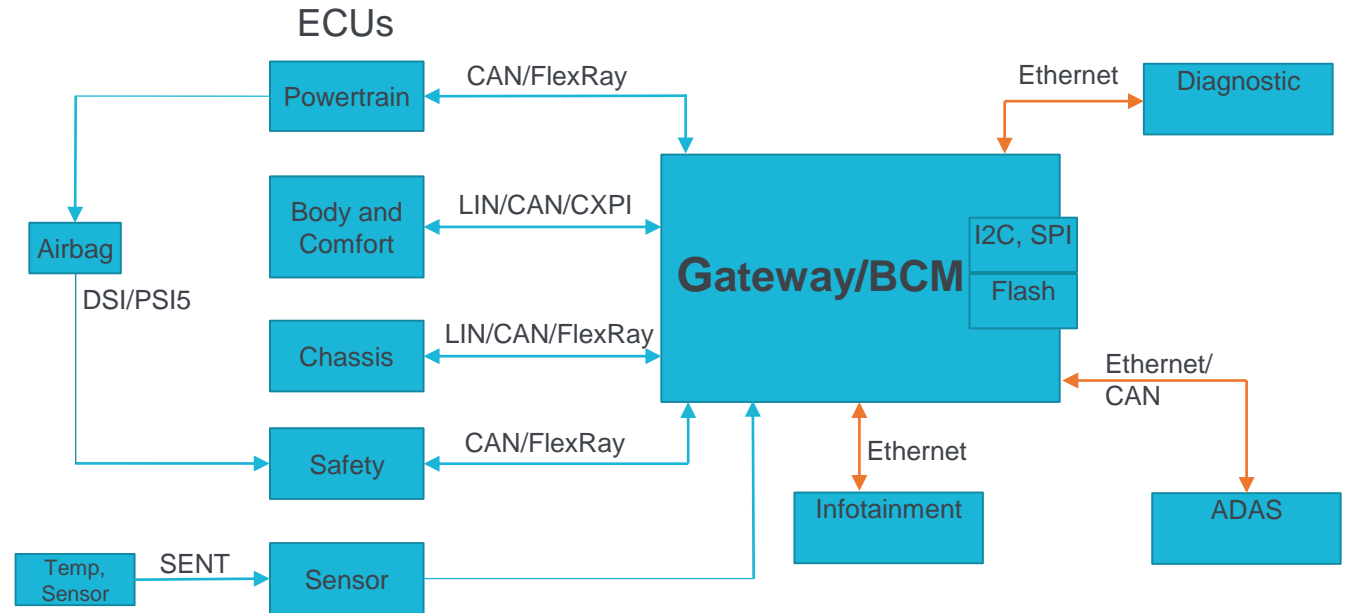


Source: Strategy Analytics

# In-Vehicle Network

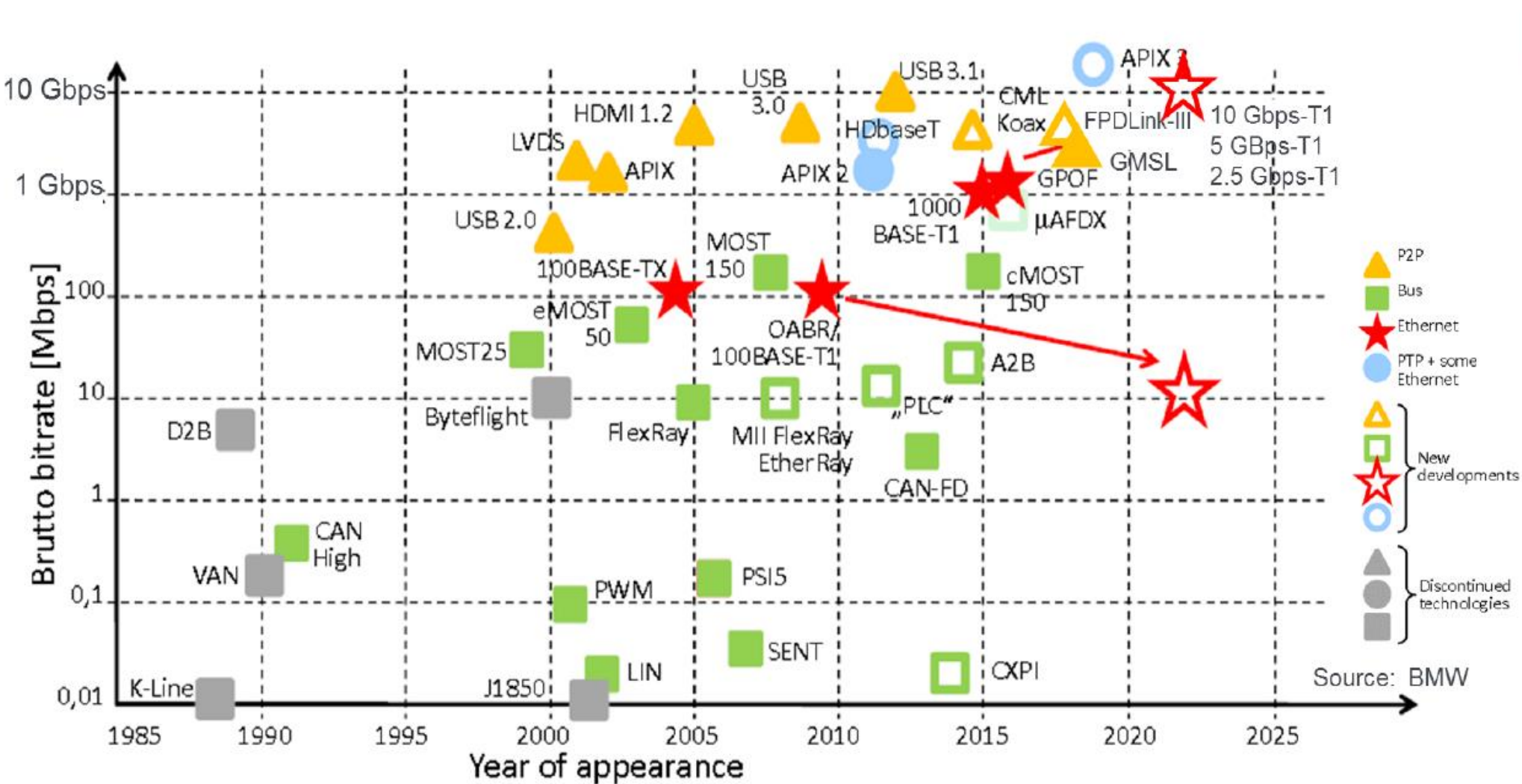
AUTOMOTIVE REQUIREMENTS PLACE HEAVY DEMANDS

- Low cost
- Reliable
- Withstand harsh environment
- Low power



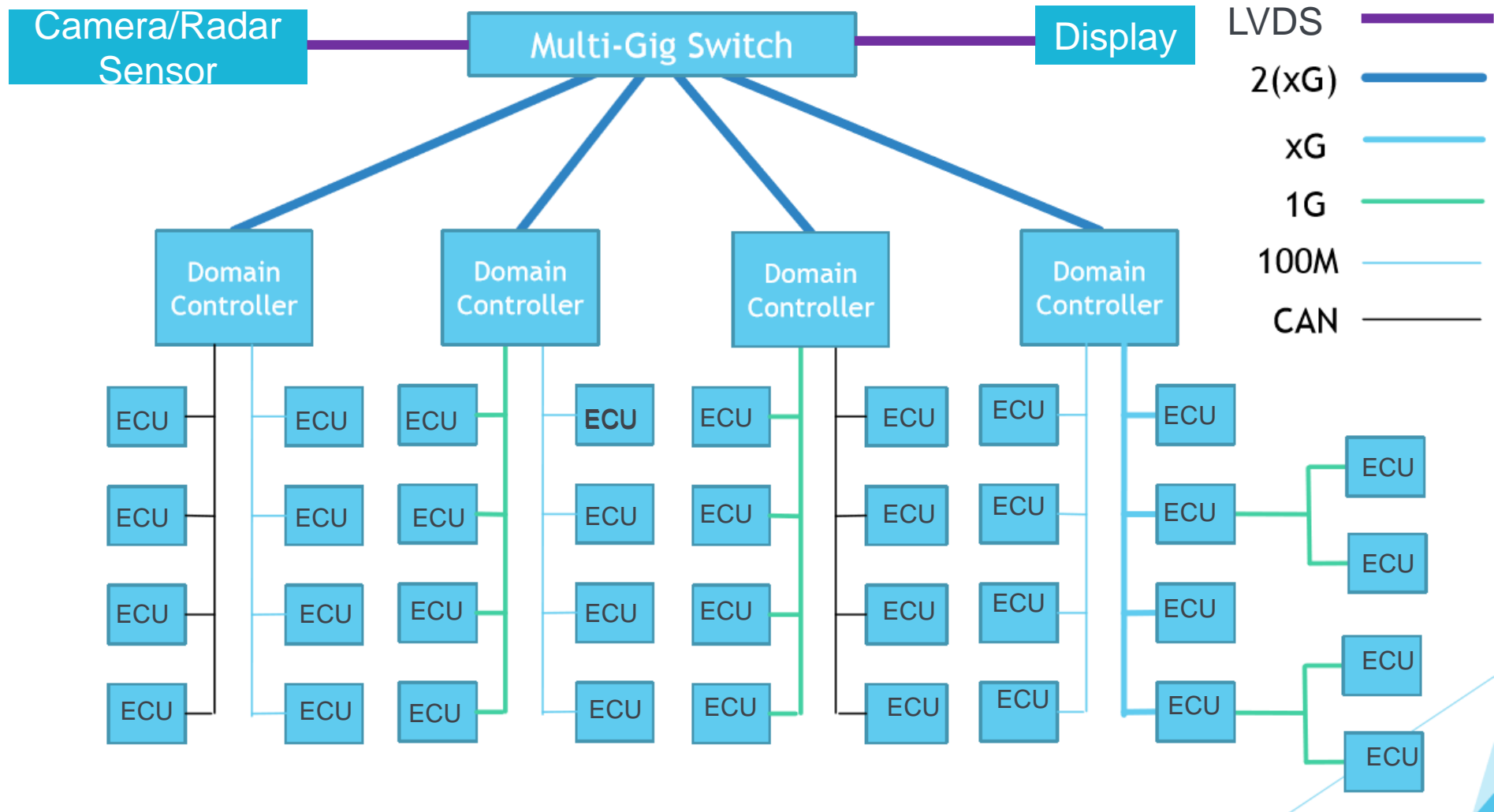
- New applications like Infotainment, Autonomous car, Connected car are driving IVN speed increases

# Automotive Serial Standard Trends



Technology	Data Rate
LVDS	2 Gbps
HDBaseT	4/8 Gbps
APIX	3 Gbps
GMSL	3.12 Gbps
FPD-Link III	4.16 Gbps
1000BASE-T1	1 Gbps
	PAM3

# In-Vehicle Network



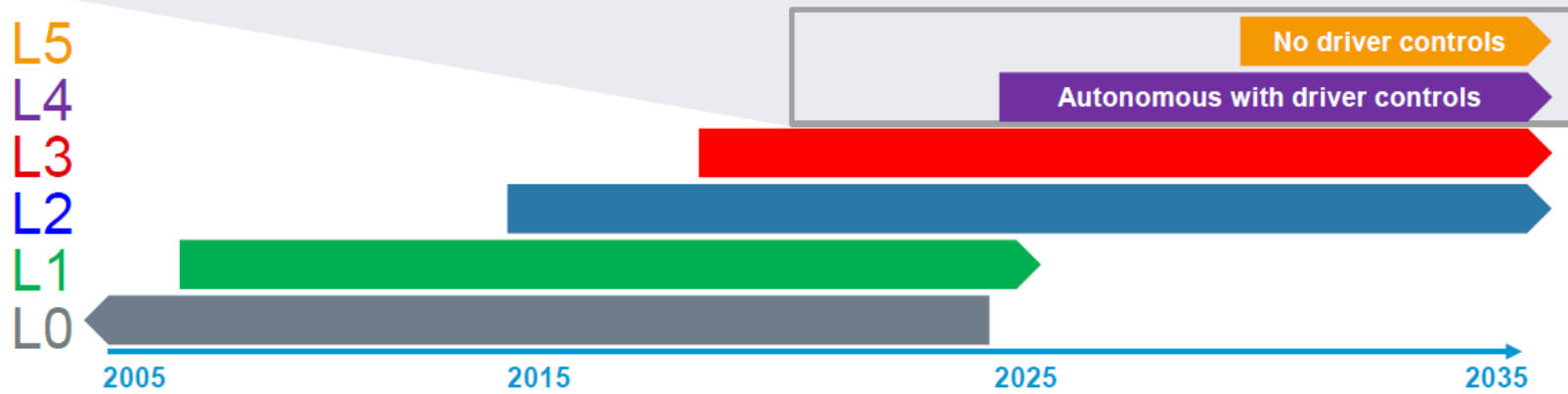
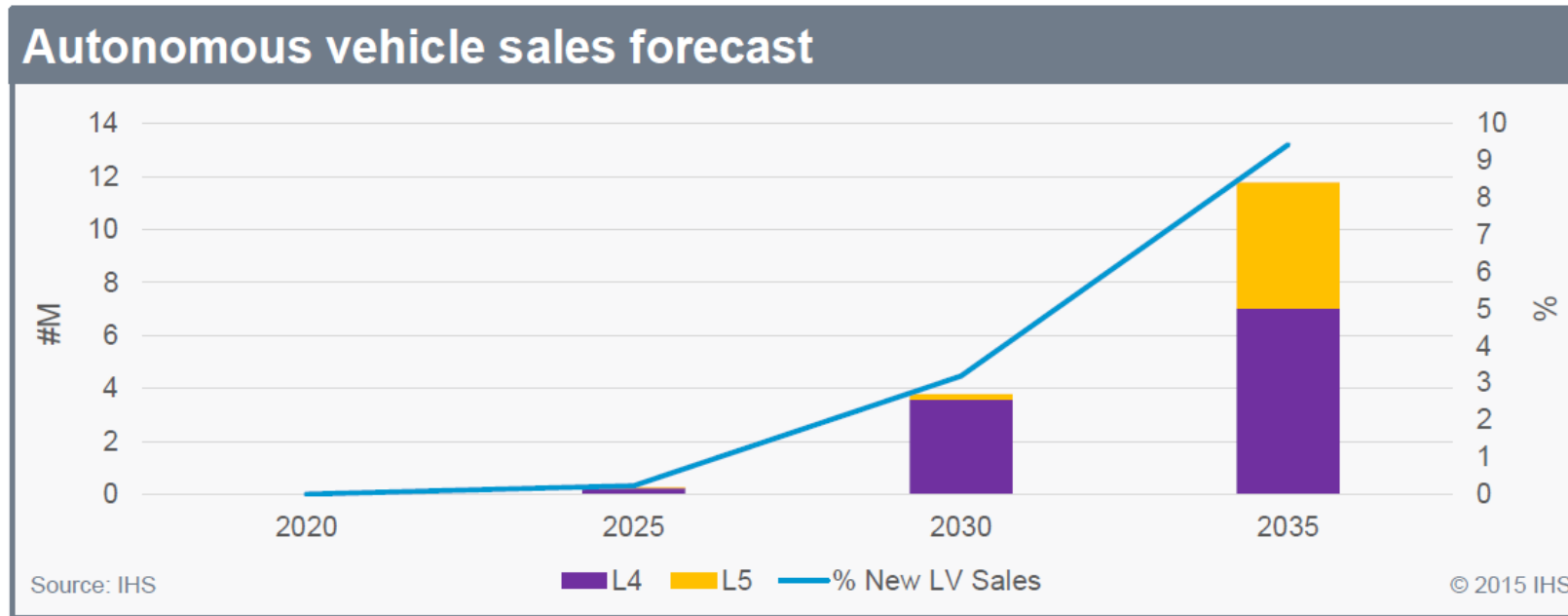
# Autonomous Driver Assistance System



# Level of Automation

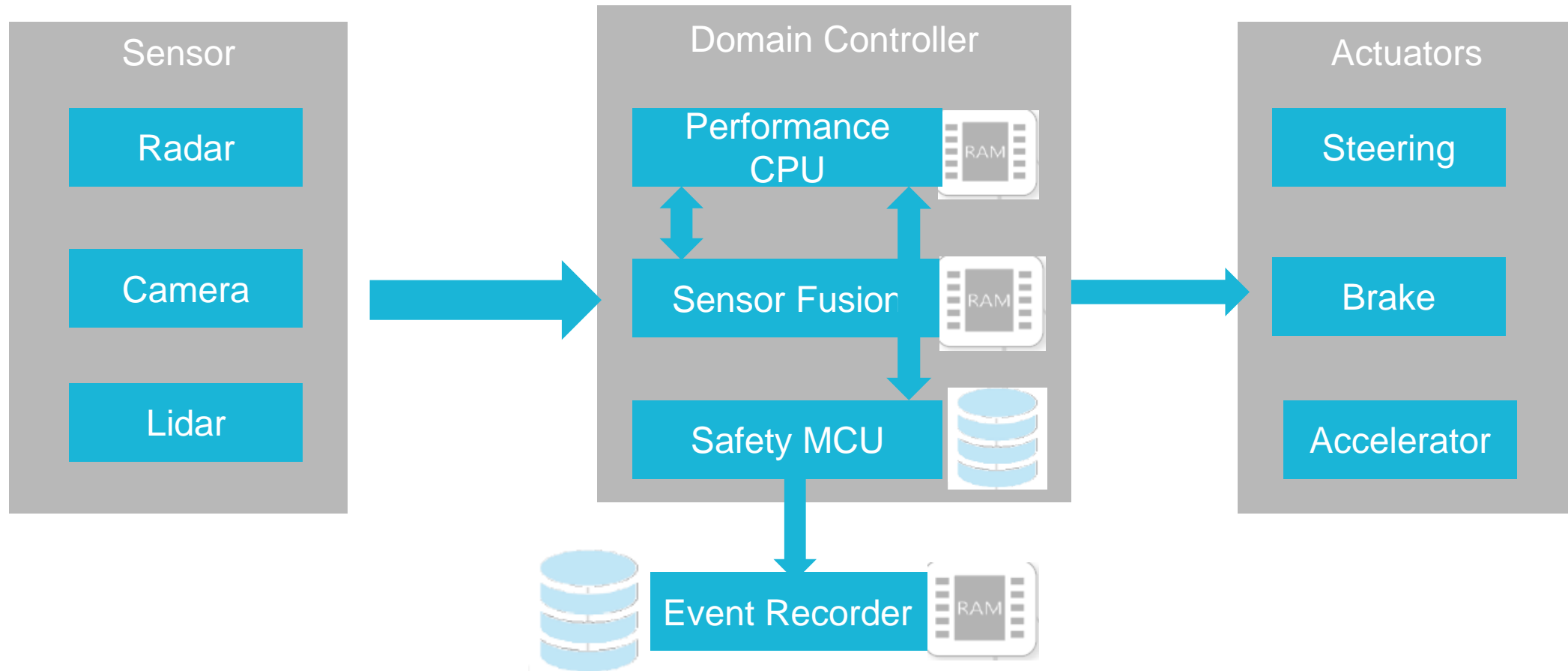
SAE level	Name	Narrative Definition	Execution of Steering and Acceleration/Deceleration	Monitoring of Driving Environment	Fallback Performance of Dynamic Driving Task	System Capability (Driving Modes)
<b>Human driver monitors the driving environment</b>						
<b>0</b>	<b>No Automation</b>	the full-time performance by the <i>human driver</i> of all aspects of the <i>dynamic driving task</i> , even when enhanced by warning or intervention systems	Human driver	Human driver	Human driver	n/a
<b>1</b>	<b>Driver Assistance</b>	the <i>driving mode</i> -specific execution by a driver assistance system of either steering or acceleration/deceleration using information about the driving environment and with the expectation that the <i>human driver</i> perform all remaining aspects of the <i>dynamic driving task</i>	Human driver and system	Human driver	Human driver	Some driving modes
<b>2</b>	<b>Partial Automation</b>	the <i>driving mode</i> -specific execution by one or more driver assistance systems of both steering and acceleration/deceleration using information about the driving environment and with the expectation that the <i>human driver</i> perform all remaining aspects of the <i>dynamic driving task</i>	<b>System</b>	Human driver	Human driver	Some driving modes
<b>Automated driving system ("system") monitors the driving environment</b>						
<b>3</b>	<b>Conditional Automation</b>	the <i>driving mode</i> -specific performance by an <i>automated driving system</i> of all aspects of the <i>dynamic driving task</i> with the expectation that the <i>human driver</i> will respond appropriately to a <i>request to intervene</i>	System	<b>System</b>	Human driver	Some driving modes
<b>4</b>	<b>High Automation</b>	the <i>driving mode</i> -specific performance by an <i>automated driving system</i> of all aspects of the <i>dynamic driving task</i> , even if a <i>human driver</i> does not respond appropriately to a <i>request to intervene</i>	System	System	<b>System</b>	Some driving modes
<b>5</b>	<b>Full Automation</b>	the full-time performance by an <i>automated driving system</i> of all aspects of the <i>dynamic driving task</i> under all roadway and environmental conditions that can be managed by a <i>human driver</i>	System	System	System	<b>All driving modes</b>

# ADAS Adaptation



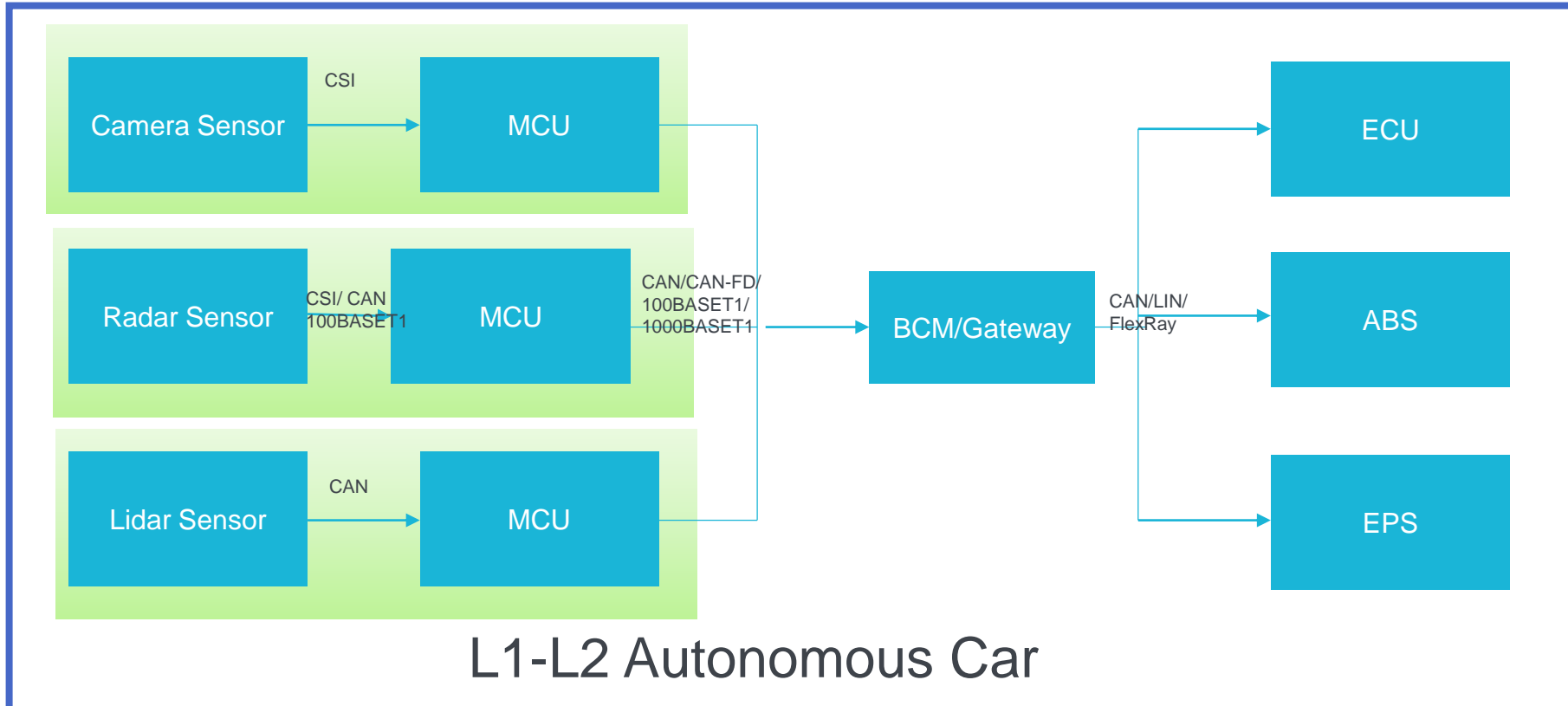
source.: IHS Automotive Seminar Frankfurt / June 2015

# ADAS Architecture



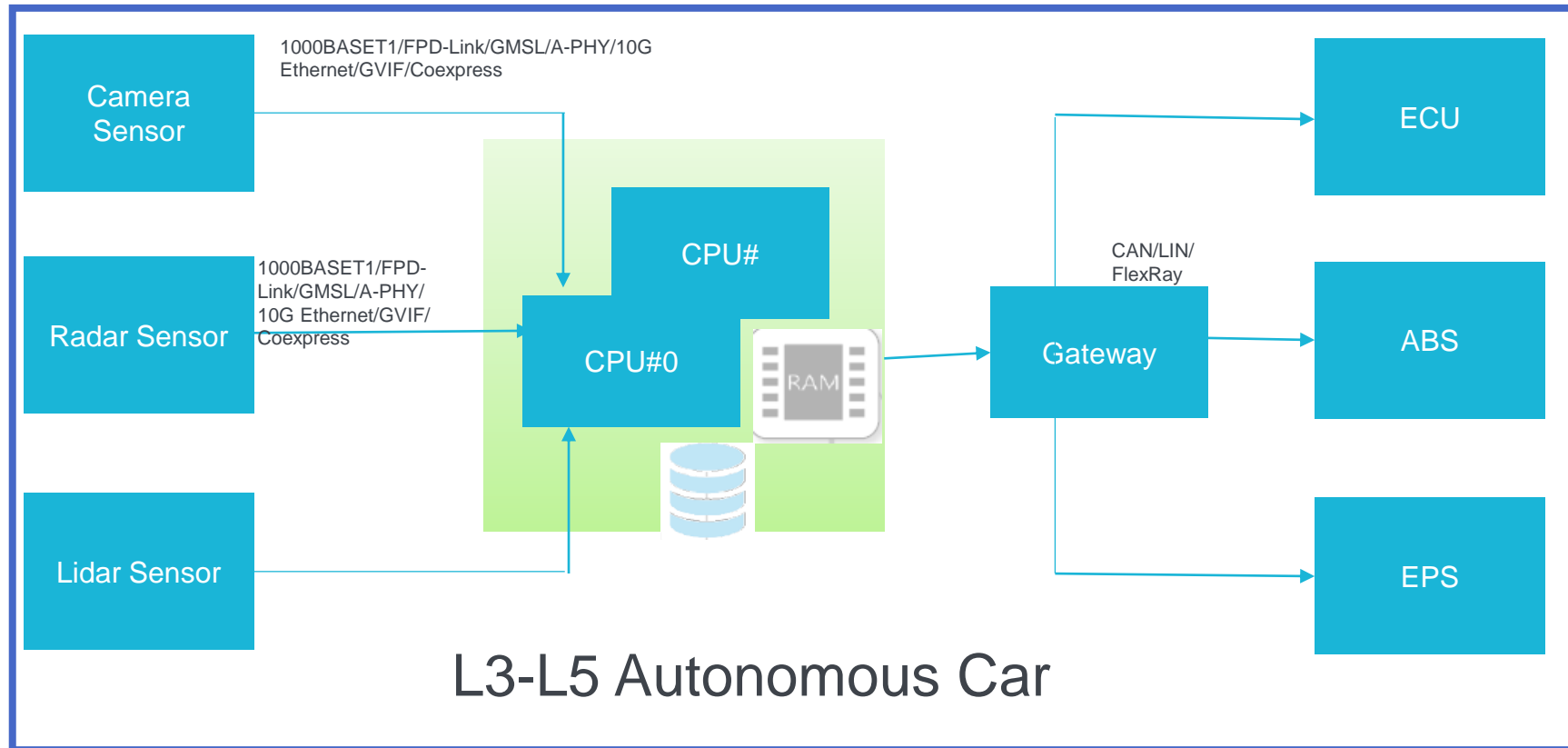
# Autonomous Car Block Diagram

## SMART SENSOR



# Autonomous Car Block Diagram

## DOMAIN CONTROLLER



# ADAS Technologies



# ADAS Technologies

ADAS			
Technology	L1-L3	L4-L5	New Technologies
Camera	D-PHY 1.2 (4 Camera)	D-PHY 1.2 (8-10 Camera)	
Radar	77GHz (1GHz BW)	77GHz (4GHz BW)	
Lidar			
ECU	CPU, DDR3, PCIeG2/3, eMMC	LPDDR4, PCIeG3, UFS	LPDDR5/GDDR6, PCIeG4, NVMe
Sensor Interface	100BASE-T1, CAN-FD	FPD-Link, GMSL, GVIF, HDBASE-T, CoeXpress	Multigigabit Ethernet, A-PHY, 1000BASE-T1, 10BASE-T1, PCIe

# Automotive Ethernet

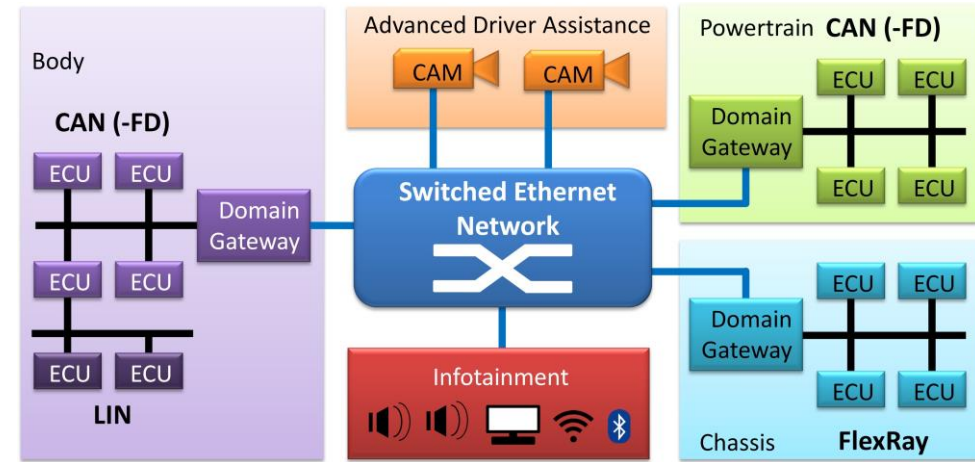
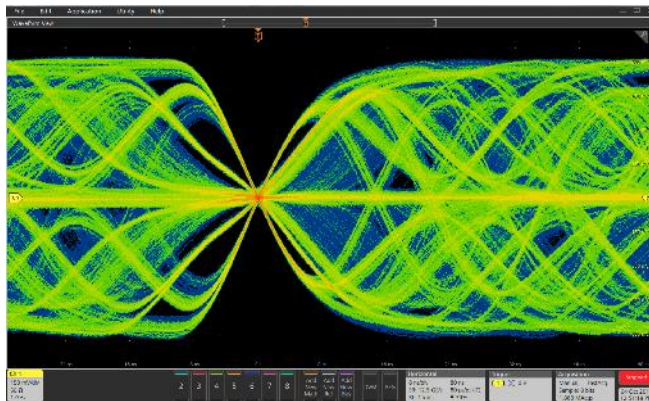
From datacenter to passenger car

# Why Automotive Ethernet?

- Enables support for high data rate applications (ADAS, IVI)
  - Low latency for ADAS (<250us)
- Well-proven technology but customized for automotive needs
- Co-exists with lower speed buses (CAN-FD, LIN, etc.)
- Creates new design validation & testing challenges



## 1000BASE-T1 PAM3



# Automotive Ethernet Standard

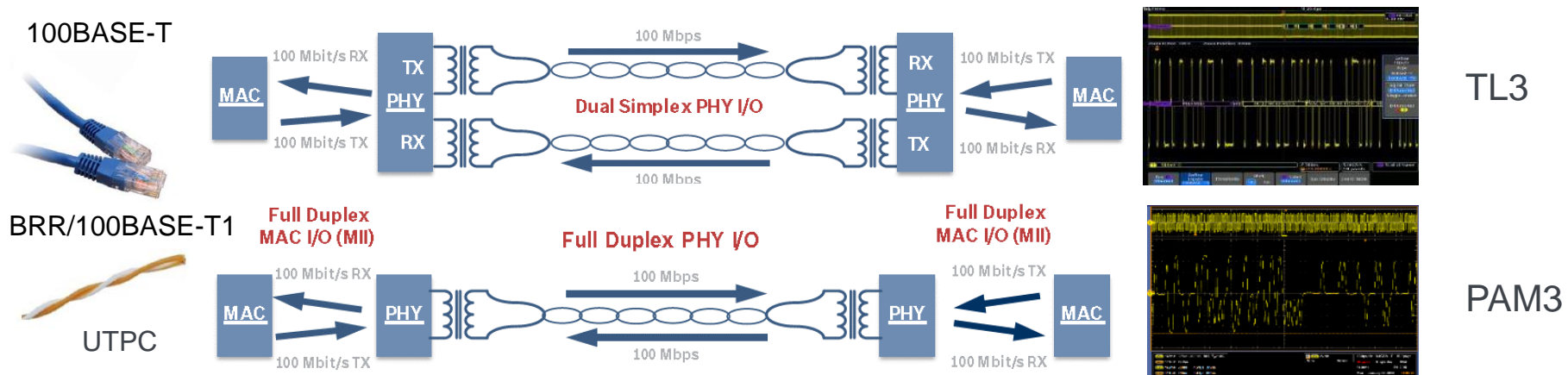
## THE EVOLUTION

- IEEE Ethernet derivative standard (BroadR-Reach) created by an industry alliance (OABR)
- IEEE has established its own standards 100BASE-T1 (P802.3bw™) and 1000BASE-T1 (802.3bp™)
- Initial deployment focused on 100 Mb/s but early development underway for 1 Gb/s
- **Multigigabit Ethernet** which would address need beyond 1G is at spec development stage

# Automotive Ethernet Standard

BASED ON ESTABLISHED ETHERNET STANDARDS, ADAPTED FOR AUTOMOTIVE

- Unshielded single twisted pair cabling designed for automotive environment and lower cost
- Higher Bandwidth compared to CAN FD (15Mbps), FlexRay (10Mbps), MoST (150Mbps)
- Can reuse existing Application Layer Ethernet stack
- Uses PAM3 signaling

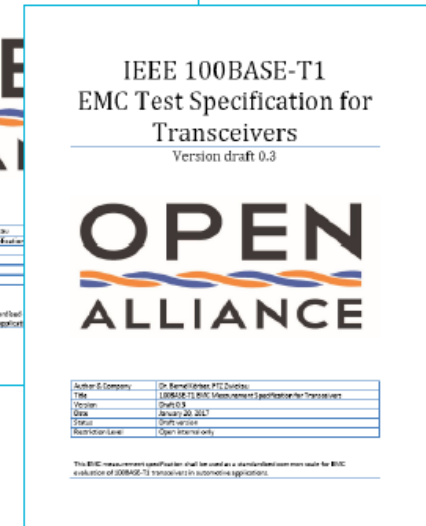
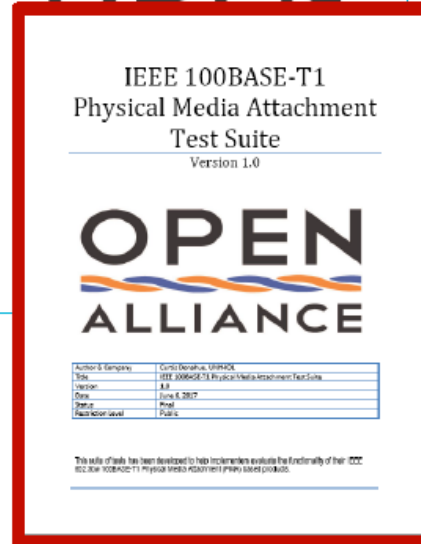
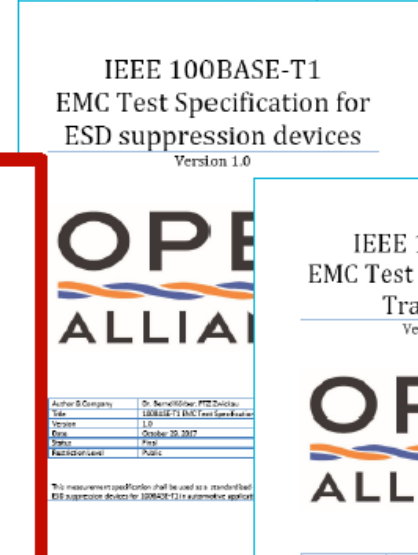
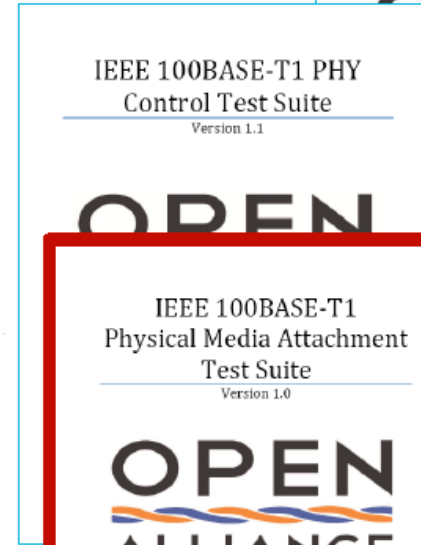
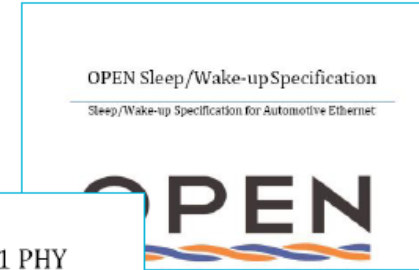
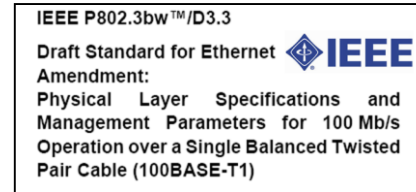


# Automotive Ethernet Compliance

Ensuring performance and interoperability

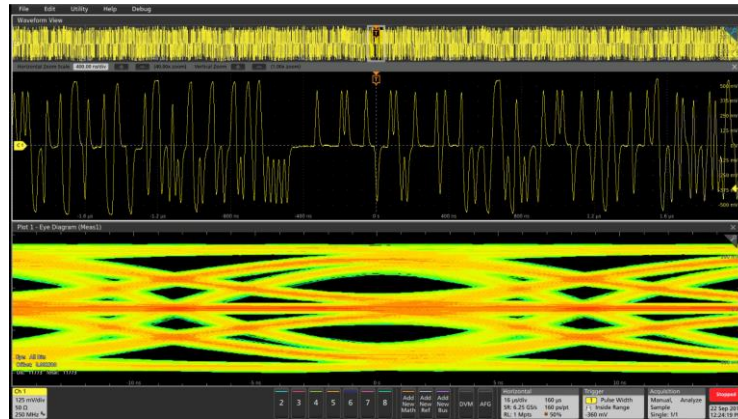
# Automotive Ethernet Test Requirement

- Multiple testing needs including physical layer (PMA) transceiver, receiver, communication channel, and EMC
  - PHY Media Attachment Test suit
  - EMC Test for Common Mode Chock
  - Interop Test
  - PHY Control Test
  - Physical coding Sublayer test
  - Communication Channel Test
  - Open Sleep/wakeup Test
  - EMC Test for Trans receiver
  - EMC Spec for ESD suppression devices



# Automotive Ethernet PMA Test Specification

- PHY Media Attachment Compliance Test
- PHY test mode configuration should be provided by PHY vendor
- Transceiver PHY electrical test requirements include:
  - Maximum Output Droop
  - Timing Jitter (master/slave)
  - MDI Output Jitter
  - Distortion
  - Power Spectral Density
  - Clock Frequency
  - MDI Return Loss
  - Peak Differential Output
- PAM3 signaling



IEEE P802.3bw™/D3.3  
 Draft Standard for Ethernet  
 Amendment:  
 Physical Layer Specifications and  
 Management Parameters for 100 Mb/s  
 Operation over a Single Balanced Twisted  
 Pair Cable (100BASE-T1)

BroadR-Reach  
 Physical Media Attachment  
 Test Suite  
 Version 2.0

**OPEN**  
 ALLIANCE



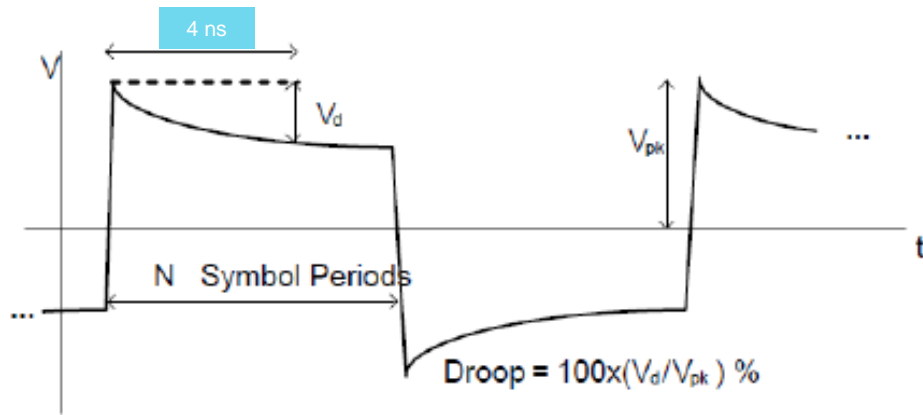
Group 1: Electrical Measurements	
Maximum Transmitter Output Droop	Test 5.1.1
Transmitter Distortion	Test 5.1.2
Transmitter Timing Jitter (MASTER, SLAVE)	Test 5.1.3
Transmitter Power Spectral Density	Test 5.1.4
Transmit Clock Frequency	Test 5.1.5
MDI Return Loss	Test 5.1.6
MDI Mode Conversion Loss	Test 5.1.7
Transmitter Peak Differential Output	Test 5.1.8

1000BASE-T1 Measurement	Spec ID
Tx Droop Measurement	5.3.1
Tx Distortion Measurement	5.3.2
Tx_TCLK125 Jitter	5.3.3
Tx_TCLK125 Jitter	5.3.3
MDI_output_Jitter	5.3.3
Tx PSD	5.3.4
Tx Peak Diff output	5.3.5
Tx Clock Frequency	5.3.6
MDI Return Loss (S11)	7.2.1
MDI Mode Conversion loss	7.2.2

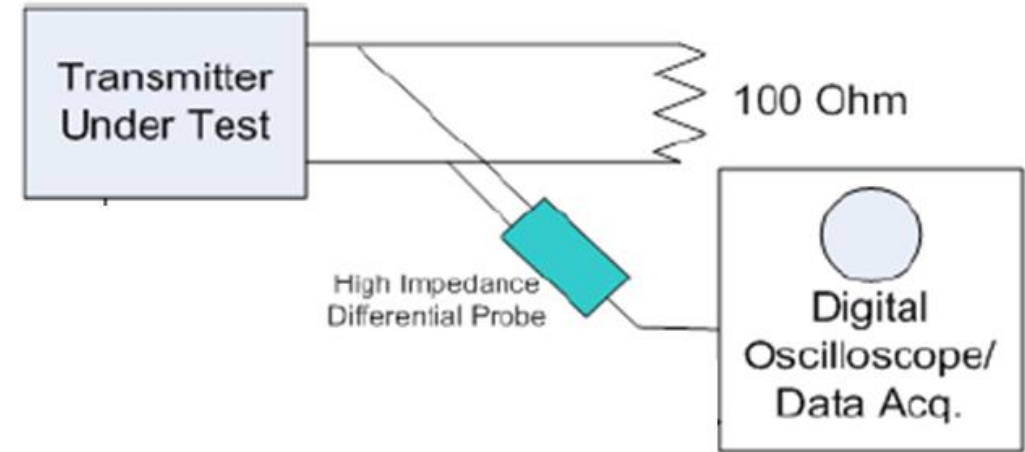
^ PMA: Physical Media Attachment

# Maximum Droop Test

- Droop Measurement
  - Configure Test Mode 1
  - Transmit fifteen {+1} symbols followed by fifteen {-1} symbols continually
  - Value of signal 4ns after initial peak, shall be less than 10.0%
  - Calculate  $V_{pk}$  and  $V_{delay}$  as shown below
  - $V_d = V_{pk} - V_{delay}$
  - $Droop = v_d/v_{pk}\%$



Droop

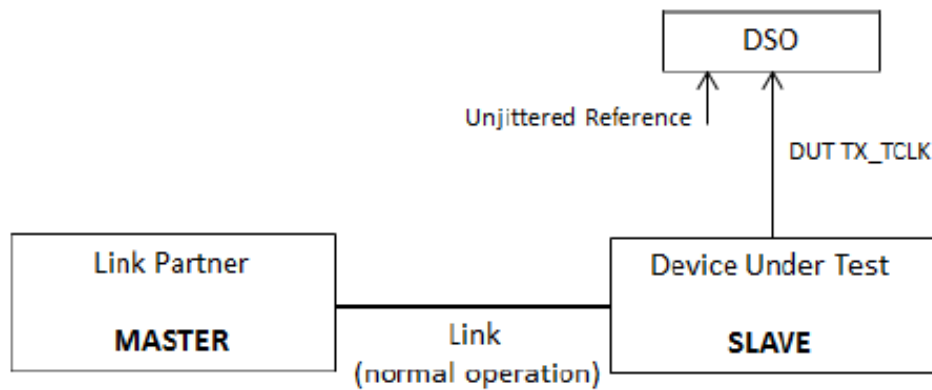
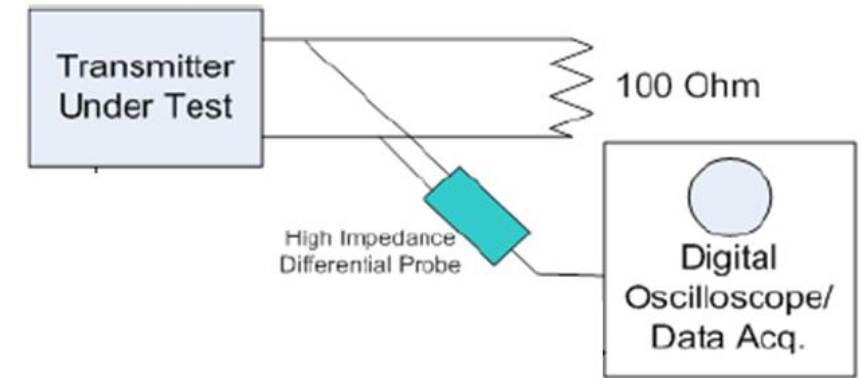


Droop



# Clock Frequency and Jitter Tests

- Clock Frequency Measurement
  - PHY device must have a symbol transmission rate of  $750 \text{ MHz} \pm 100\text{ppm}$  (master clock should be  $125 \text{ MHz}$ )
- Timing Jitter (master & slave) Measurement
  - Transmitter clock measurement
  - RMS PHY output jitter shall be less than  $5 \text{ ps}$
  - Slave jitter requires un jittered reference,
  - RMS PHY jitter shall be less than  $10\text{ps}$  for Slave



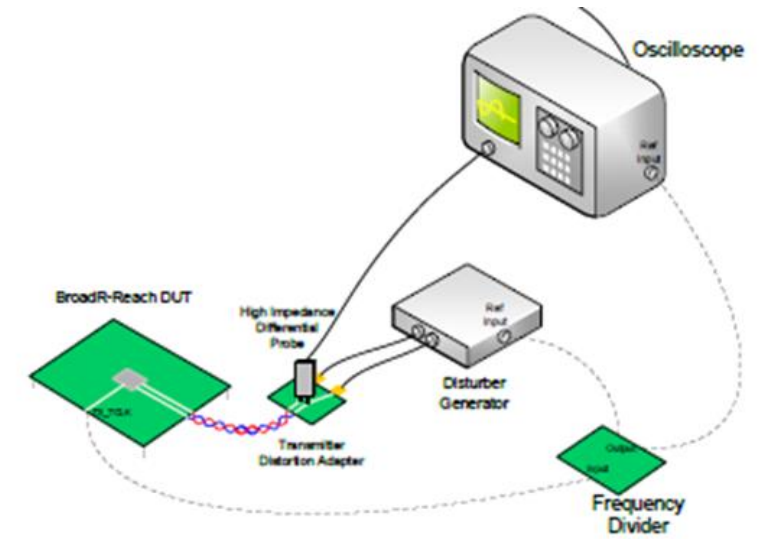
Slave Jitter

## Clock Frequency & Jitter

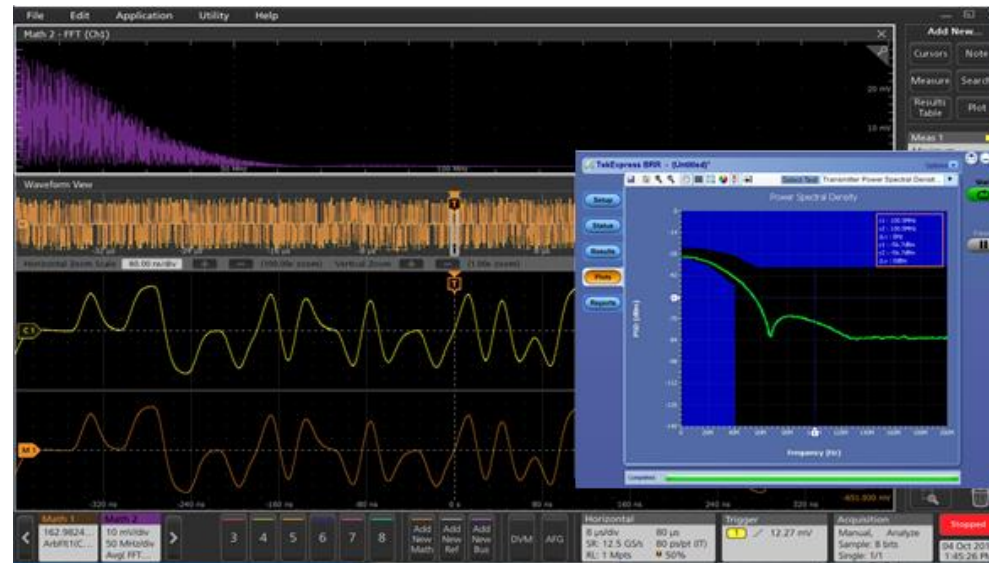


# Power Spectral Density

- Power Spectral Density
  - Configure Test Mode 5
  - Random sequence of ternary (PAM3) codes  $\{-1, 0, +1\}$
  - Max & min mask defines limits at 4 specific frequencies
  - RBW = 10 KHz, VBW = 30 KHz, Sweep time > 60 seconds
  - Compliance test spec allows use of scope or spectrum analyzer

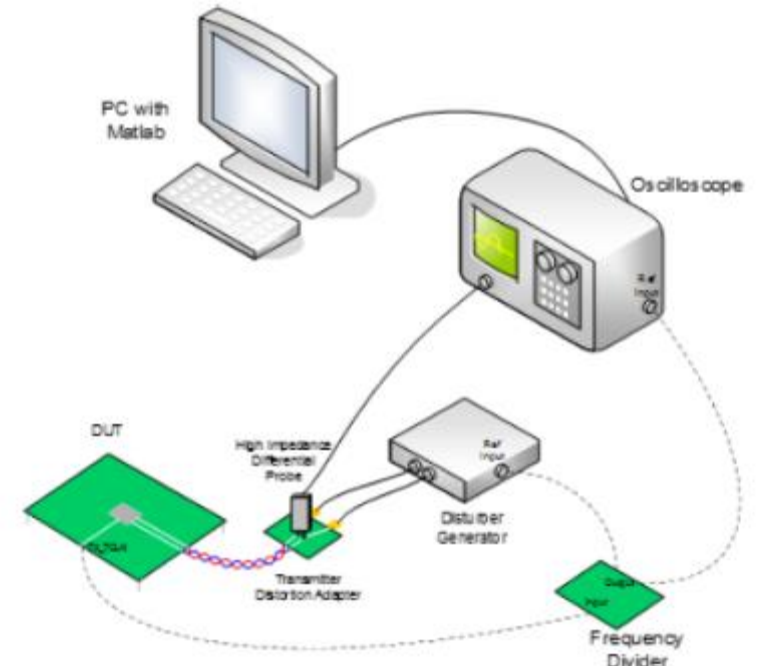


PSD

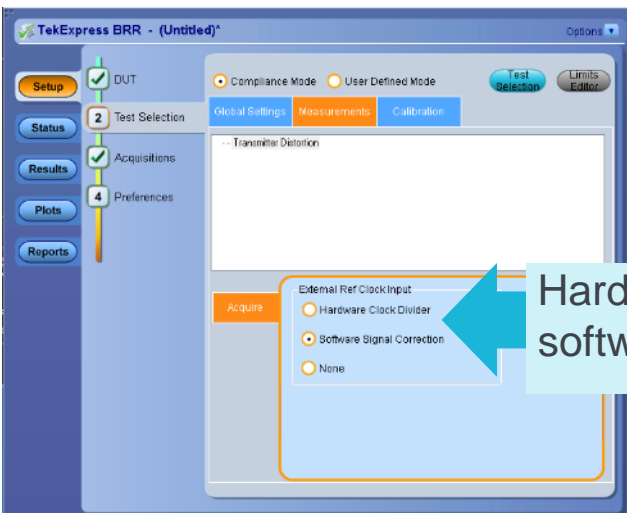


# Distortion Test

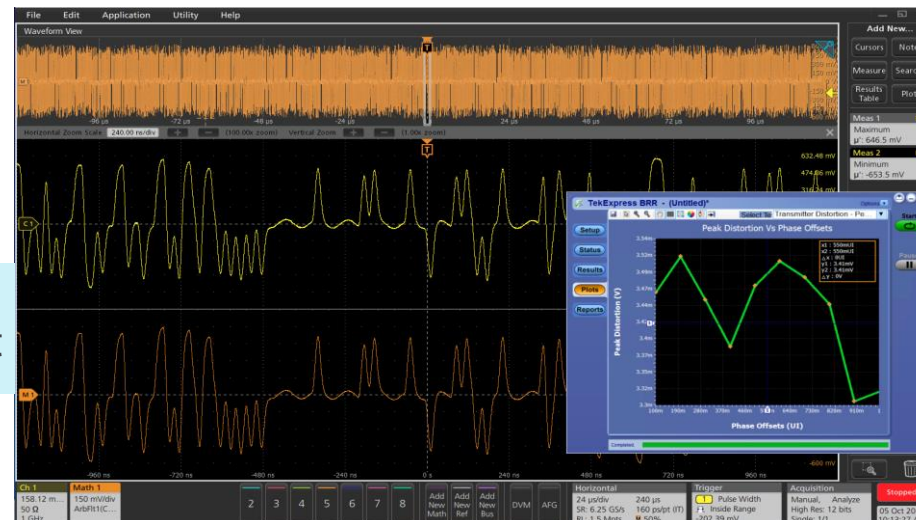
- Distortion Measurement
  - Peak distortion values should be less than 15 mV for at least 10 measured equally spaced phase
  - Requires generator to provide 125 MHz distortion signal which is 1/6 symbol rate
  - Requirement to synch scope and generator with PHY Tx-TCLK (distortion results are higher without this technique)
  - Alternative to hardware synch is software correction



## Distortion



Hardware or software support

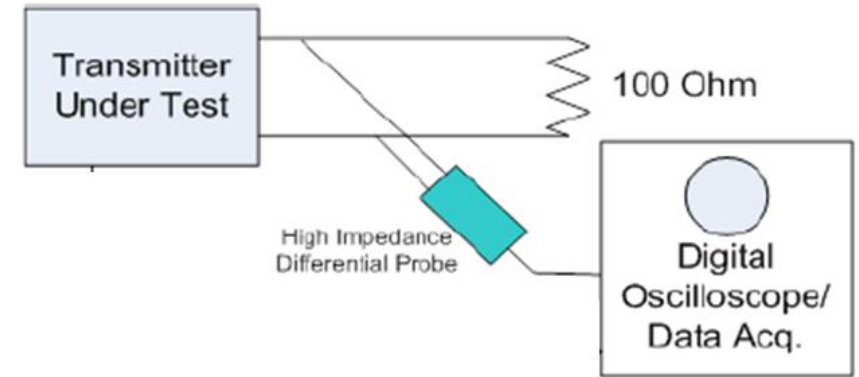


BroadR-Reach Clock Frequency Divider



# Tx Peak Differential Output Test

- Peak Differential Output Test
  - Peak-to-peak differential amplitude shall be less than 2.2 VPP when measured with a 100  $\Omega$  termination
  - DUT is configured as MASTER and in the TRAINING state of the PHY Control state
  - Configured for Test Mode 5, described as “Normal operation at full power”

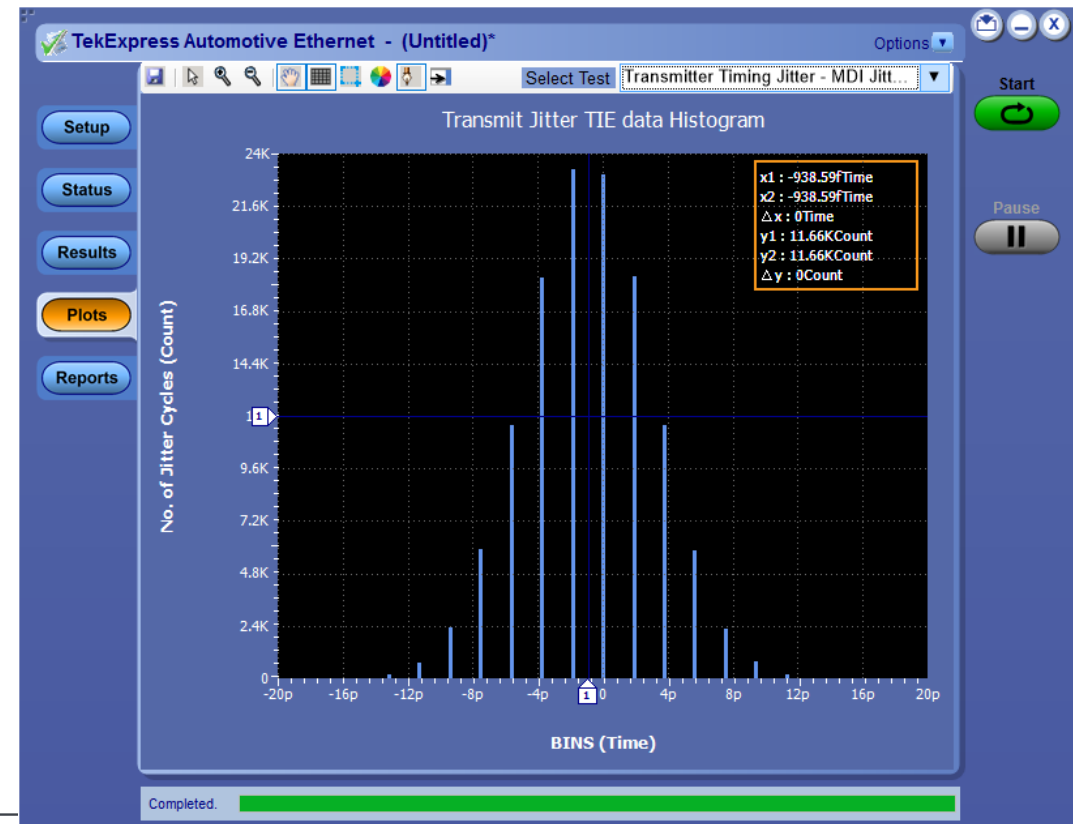
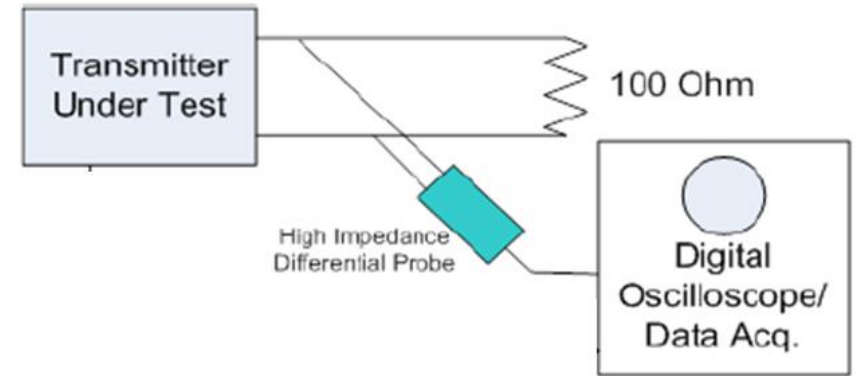


## Differential Output



# MDI Output Jitter

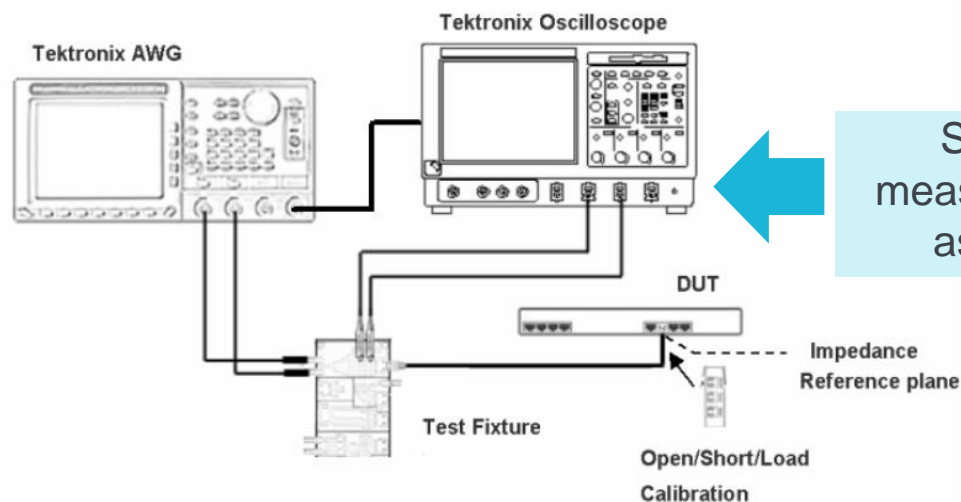
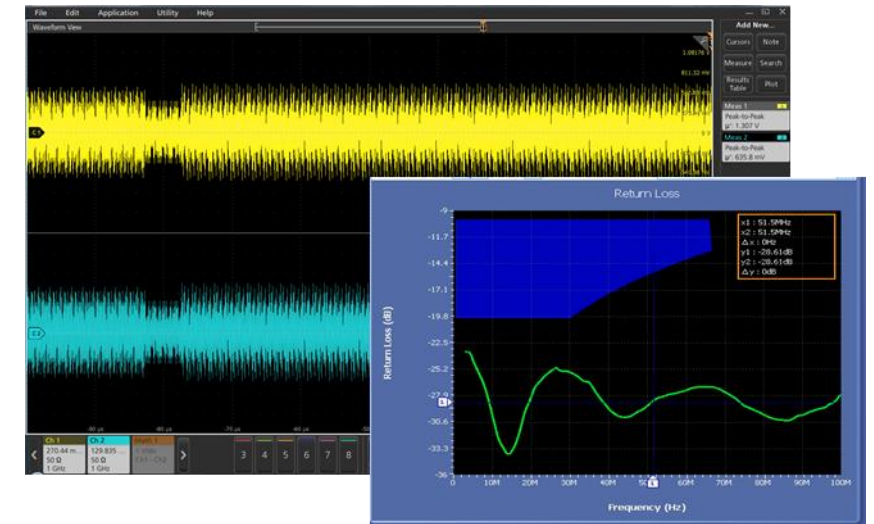
- MDI output Jitter
  - Transmit three {+1} symbols followed by three {-1} symbols continually
  - RMS PHY MDI output jitter shall be less than 5 ps



# MDI (connector) Return Loss Test

- Return Loss Measurement
  - Measurement is focused on the connector and not the link (cable) return loss
  - Test spec references VNA or scope as measurement tool
  - Return loss measured at the MDI shall be at least 18 dB (1 to 20 MHz), and at least  $18 - 10 \cdot \log_{10}(f/20)$  dB (20 to 66 MHz)
  - Max & min mask defines limits at 4 specific frequencies
  - Tek has patented approach using scope and AWG (same equipment used for other tests)


## Return Loss using scope



# 100BASE-T1 compliance

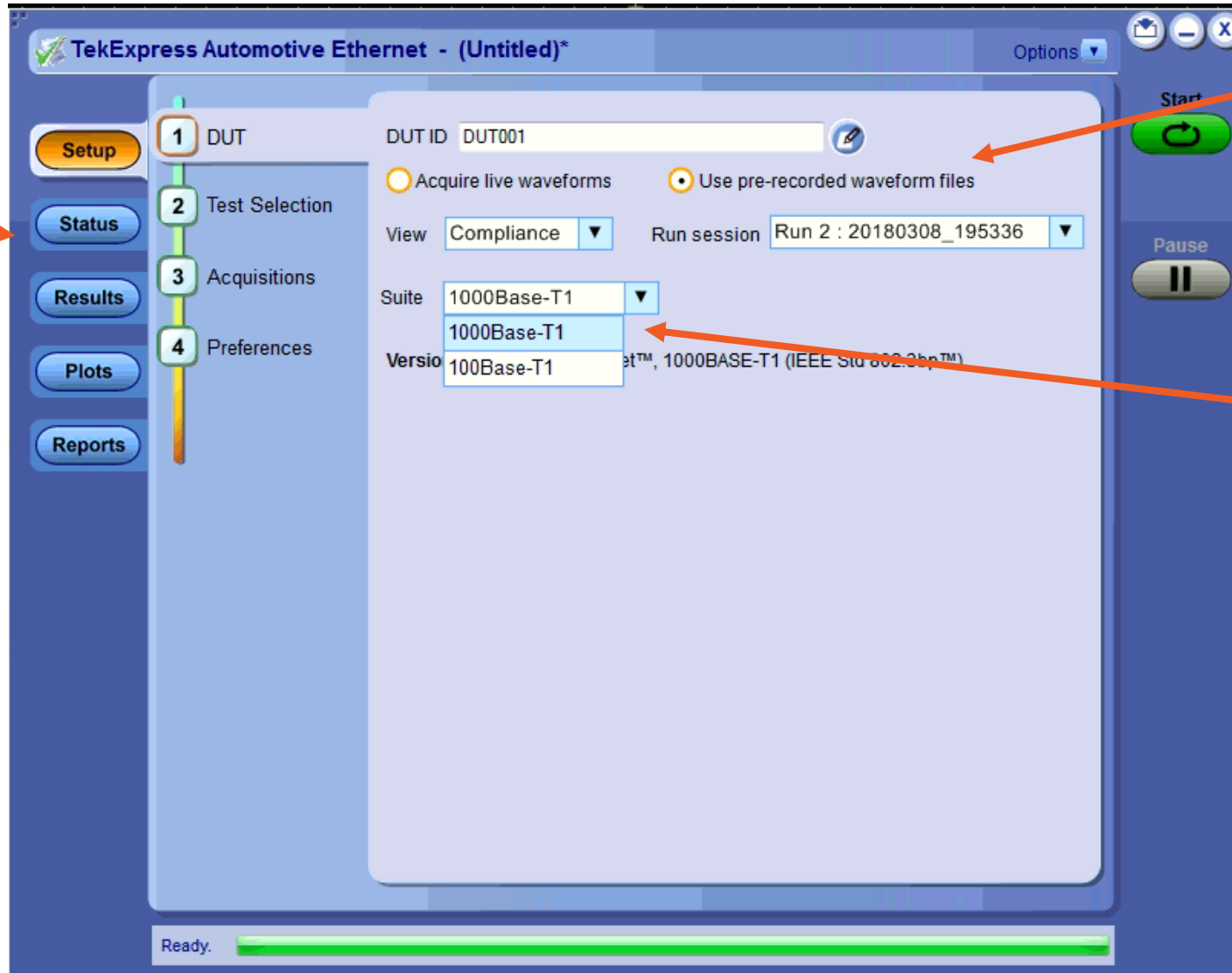
100BASE-T1 Electrical Measurement							
Measurement	Test Mode	Pin	Test Pattern	Spec			Instrument
Tx Droop Measurement	1	BI_DA	Transmit fifteen {+1} symbols followed by fifteen {-1} symbols continually	Max Droop after 500ns of 45%			Scope
Tx Distortion Measurement	4	BI_DA	Transmit the sequence of symbols generated by the scrambler generator polynomial per Equation (97-12) when in test mode 4, 40us long	>15mV			Scope+ AWG
Clock Jitter (Master)	2	BI_DA	Frequency reduced version of Transmit symbol clock	RMS Jitter <50ps (Master)			Scope
Clock Jitter (Slave)	3	BI_DA	Frequency reduced version of Transmit symbol clock	RMS Jitter <150ps (Slave)			Scope
Tx Power spectral Density (PSD)	5	BI_DA	Sequence of -1, 0, +1	<b>Freq</b>	<b>PSD Upper</b>	<b>PSD Lower</b>	Scope
				@1MHz	-23.3 dBm	-30.9dBm	
				@20MHz	-24.8 dBm	-35.8dBm	
				@40MHz	-28.5dBm	-49.2dBm	
				57MHz -200MHz	-36.5dBm		
Tx Peak Diff output	5	BI_DA		<2.2Vpp			Scope
Tx Clock Frequency	2	BI_DA	+1, -1 Clock sequence	66.66 MHz ± 100ppm			Scope
<b>MDI</b>							
MDI Return Loss (S11)	4	BI_DA	PAM3 Data pattern	below 18dB (1-20MHz) 18*10log(f/20) dB (20-66MHz)			Scope +AWG/VNA
MDI Mode Conversion loss (Sdc11)		BI_DA	Coming soon				

# 1000BASE-T1 Compliance

1000BASE- T1 Electrical Measurement					
Measurement	Test Mode	Pin	Test Pattern	Spec	Instrument
Tx Droop Measurement	6	BI_DA	Transmit fifteen {+1} symbols followed by fifteen {-1} symbols continually	Less than 10% measured with respect to an initial value at 4 ns after the zero crossing and a final value at 16 ns after the zero crossing	Scope
Tx Distortion Measurement	4	BI_DA	Transmit the sequence of symbols generated by the scrambler generator polynomial when in test mode 4, 40us long	Less than 15 mV for at least 10 measured equally spaced phases	Scope+ AWG
Tx_TCLK125 Jitter	1	BI_DA	Frequency reduced version of Transmit symbol clock	>5ps RMS, >50ps pp	Scope
Tx_TCLK125 Jitter	1	BI_DA	Frequency reduced version of Transmit symbol clock	>10ps RMS, >100ps pp	Scope
MDI_output_Jitter	2	BI_DA	Transmit three {+1} symbols followed by three {-1} symbols continually	>5ps RMS, >50ps pp	Scope
Tx PSD	5	BI_DA	Sequence of -1, 0, +1	 <p>The graph shows the Power Spectral Density (PSD) mask for 1000 Base-T1. The x-axis represents frequency in MHz from 0 to 700, and the y-axis represents PSD in dBm from 0 to -60. Two lines are plotted: an orange line representing the upper limit and a blue line representing the lower limit. Both lines show a downward trend as frequency increases, starting around -30 dBm at 0 MHz and reaching approximately -45 dBm at 700 MHz.</p>	Scope
Tx Peak Diff output	5	BI_DA	Sequence of -1, 0, +1		<1.3Vpp
Tx Clock Frequency	2	BI_DA	+1, -1 Clock sequence	750MHz +- 100ppm	Scope
<b>MDI</b>					
MDI Return Loss (S11)	4	BI_DA	PAM3 Data pattern		Scope + AWG/VNA
MDI Mode Conversion loss (Sdc11)		BI_DA		Coming Soon	

# Automated Compliance

Wizard-based automation



Live or offline testing

Latest 100/1000BASE-T1 support

# Test Selection

Select multiple tests

The screenshot shows the TekExpress Automotive Ethernet software interface. The main window is titled "TekExpress Automotive Ethernet - (Untitled)\*". On the left, there is a navigation pane with buttons for "Setup", "Status", "Results", "Plots", and "Reports". A vertical bar on the left indicates the current step in the process: "DUT" (checked), "2 Test Selection" (highlighted with a red box), "Acquisitions" (checked), "Configuration" (checked), and "Preferences" (checked). The main area displays "Automotive Ethernet 1000BASE-T1 Specifications" with "Deselect All" and "Select All" buttons. A list of tests is shown with checkboxes: "Transmit Clock Frequency and MDI Jitter" (checked), "Transmit Clock Frequency" (checked), "Transmitter Timing Jitter - MDI Jitter" (checked), "Transmitter Timing Jitter" (checked), "Transmitter Timing Jitter - Master Jitter" (checked), "Transmitter Timing Jitter - Slave Jitter" (checked), "Transmitter Output Droop" (checked), "Transmitter Power Spectral Density" (checked), "Transmitter Peak Differential Output" (checked), "Transmitter Distortion" (unchecked), and "Return Loss" (unchecked). Below the list is a "Test Description" section with a text area containing: "To verify the transmitter differential signal's peak to peak amplitude value is within the conformance limit. It should be less than 1.30 Volts peak-to-peak." A "Schematic" button is located to the right of the description. On the right side of the interface, there are "Start" and "Pause" buttons. At the bottom, a status bar shows "Stopped." and a progress bar.

Test description with connection diagram

# User-Defined Mode

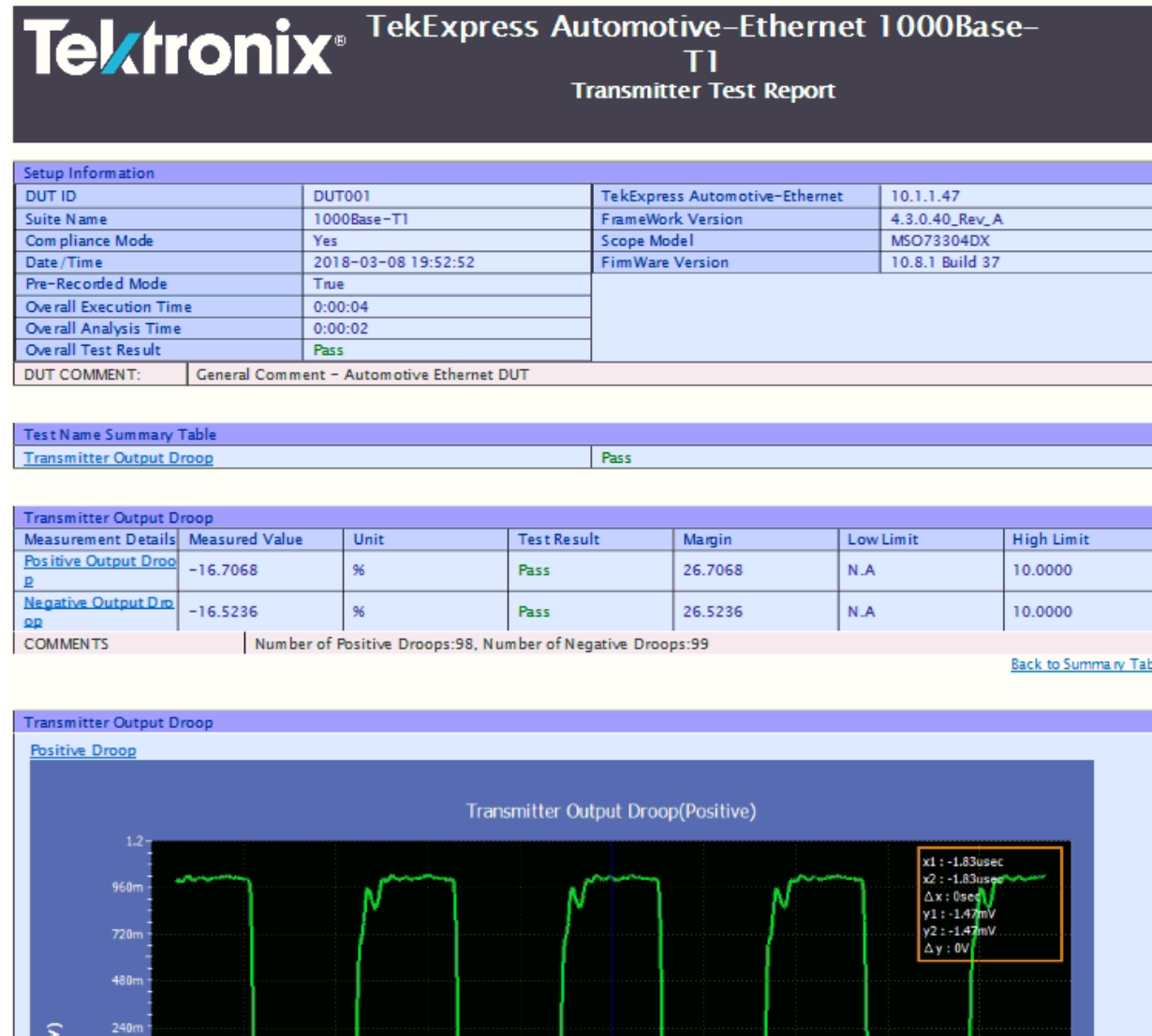
Set your own custom limits

The screenshot displays the TekExpress Automotive Ethernet software interface. The main window is titled "TekExpress Automotive Ethernet - (Untitled)\*" and shows the "User Defined Mode" selected. The "Measurements" tab is active, listing various test parameters such as "Transmit Clock Frequency and MDI Jitter", "Transmitter Timing Jitter", and "Transmitter Output Droop". A "Limits Editor" dialog box is open in the foreground, showing a table of measurement limits. The table has columns for Test Name, Details, Compare String, Low Limit, Compare String, and High Limit. The "Record Length" is set to 2.75 M. The "Limits Editor" dialog box contains the following table:

Test Name	Details	Compare String	Low Limit	Compare String	High Limit
Transmit Clock Frequency	Tx Clock Frequency	> Greater Than	124.9875	< Less Than	125.0125
	Tx Symbol Frequency	> Greater Than	749.925	< Less Than	750.075
Transmitter Timing Jitter - MDI Jitter	MDI Jitter RMS	<= Less Than Or E...	NA	N.A	5
	MDI Jitter Pk-Pk	<= Less Than Or E...	NA	N.A	50
Transmitter Timing Jitter - Master Jitter	Master Jitter RMS	<= Less Than Or E...	NA	N.A	5
	Master Jitter Pk-Pk	<= Less Than Or E...	NA	N.A	50
Transmitter Timing Jitter - Slave Jitter	Slave Jitter RMS	<= Less Than Or E...	NA	N.A	10
	Slave Jitter Pk-Pk	<= Less Than Or E...	NA	N.A	100
Transmitter Output Droop	Positive Output Droop	<= Less Than Or E...	NA	N.A	10

# Automated Report Generation

Report with  
Pass/Fail, Margin  
and Plots



# Automotive Ethernet Signal Qualification

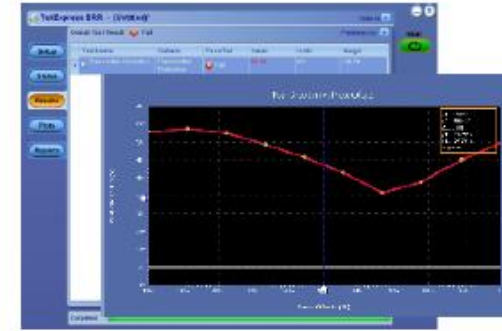
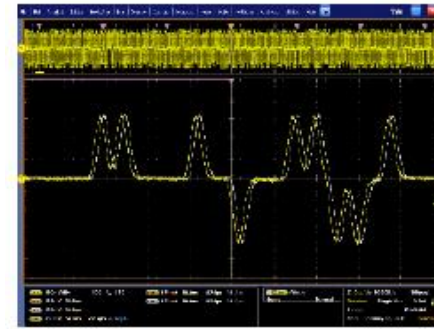
Validation and debugging

# Signal Qualification

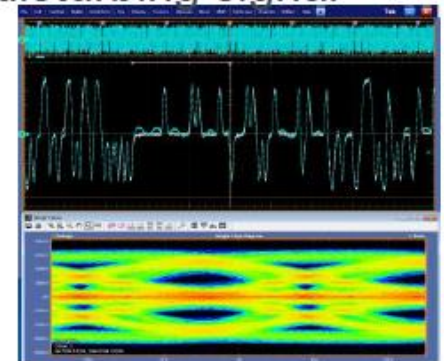
- Compliance software is being used for design and validation
- What do you do when a measurement fails?
- How would you run Signal Qualification?
- Design validation extends beyond PHY and can include Cabling and System level Test



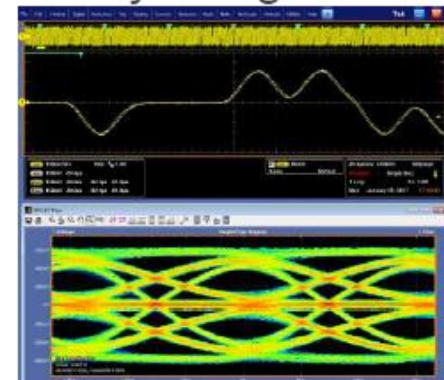
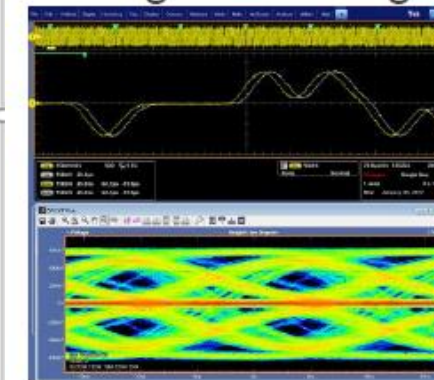
Compliance failure without disturbing signal



Distortion analysis with disturbing signal



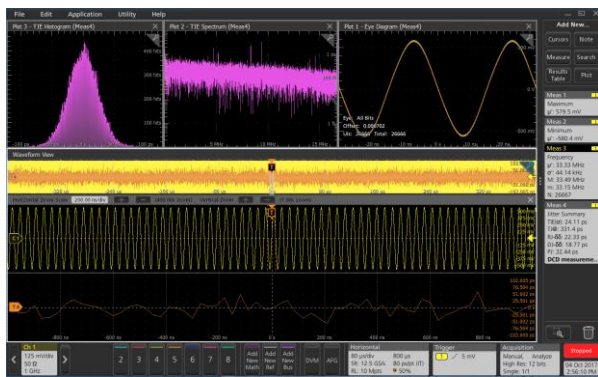
Timing error using DPOJET eye diagram



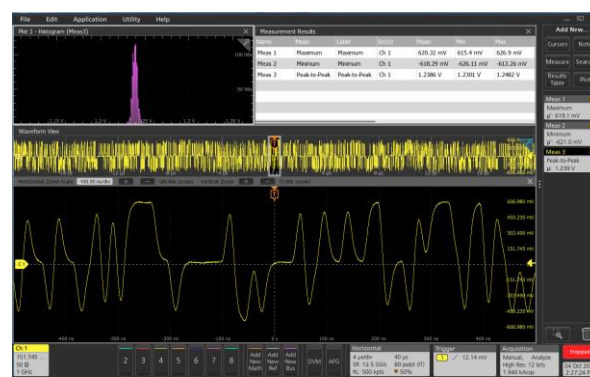
# Signal Qualification

## COMPLETE VALIDATION AND DEBUG ENSURES PASSING COMPLIANCE TESTS

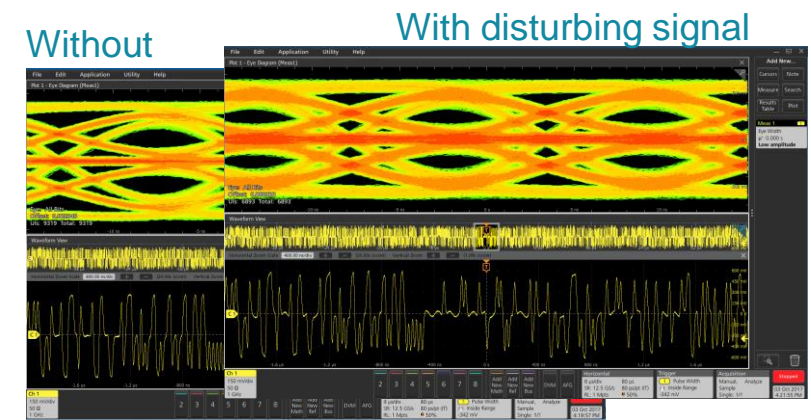
- Signal qualification can be performed using scope's advanced measurement and analysis tools ahead of compliance testing
- Designs can be validated under different operating and stress conditions
- Characterization can include jitter analysis, voltage/timing measurements and eye diagram analysis of PAM3 signaling
- Correlate results and debug if needed against compliance tests



PHY Jitter/timing analysis



Differential amplitude profile



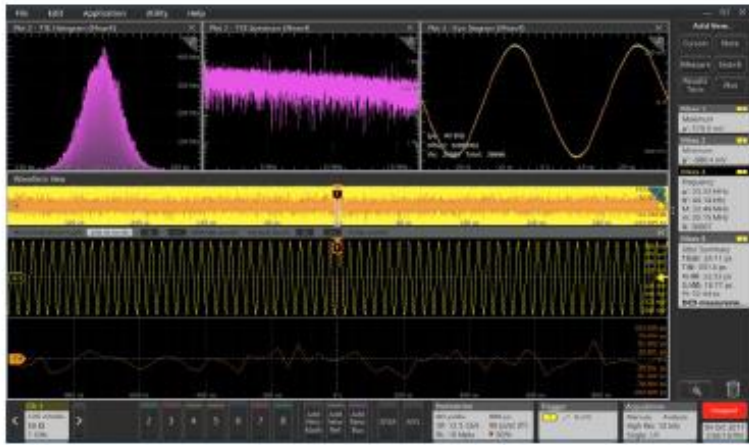
Distortion signal eye analysis

# Validation and Compliance flow

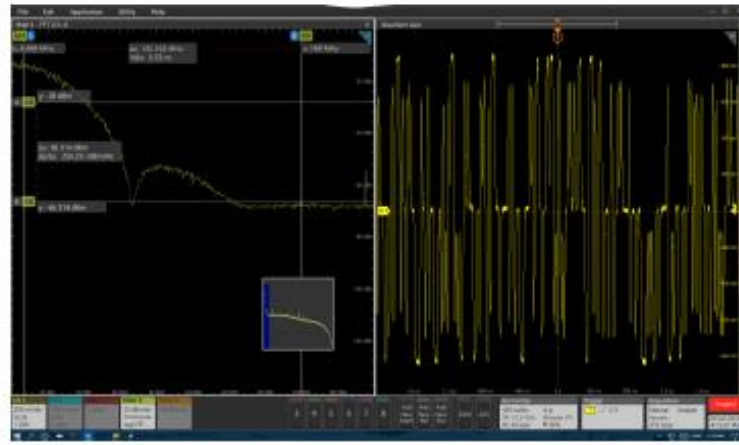
Validation/Debug



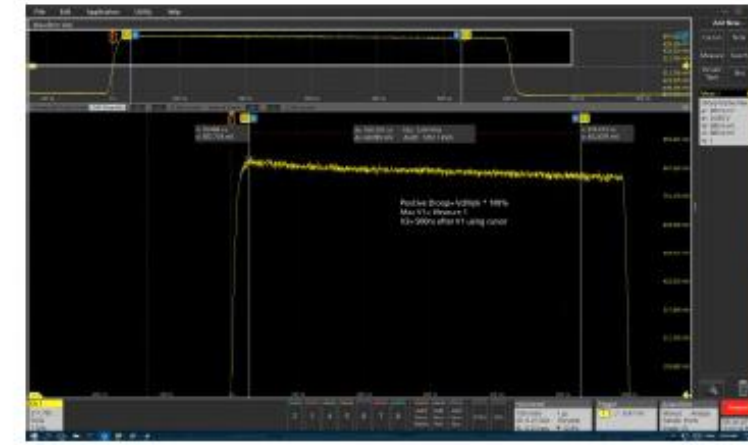
Compliance



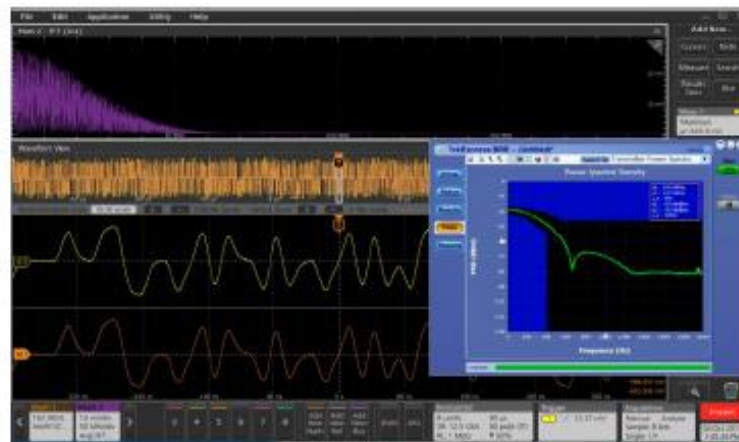
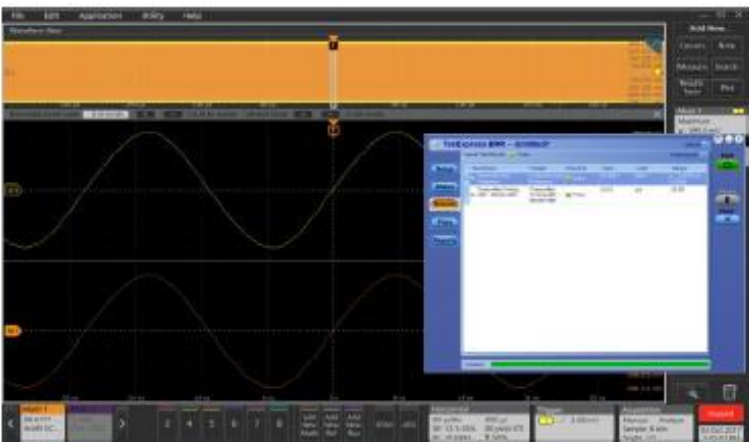
Tx Clock Frequency & Jitter



Tx Power Spectral Density



Tx Droop

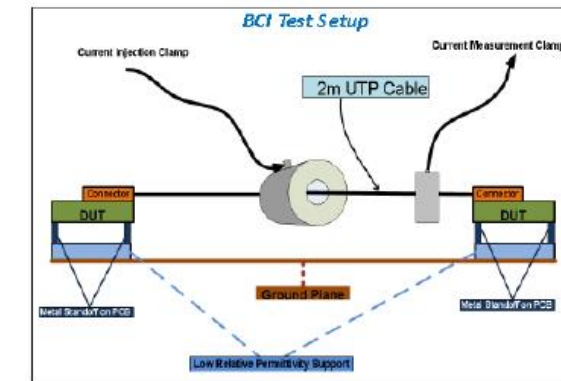
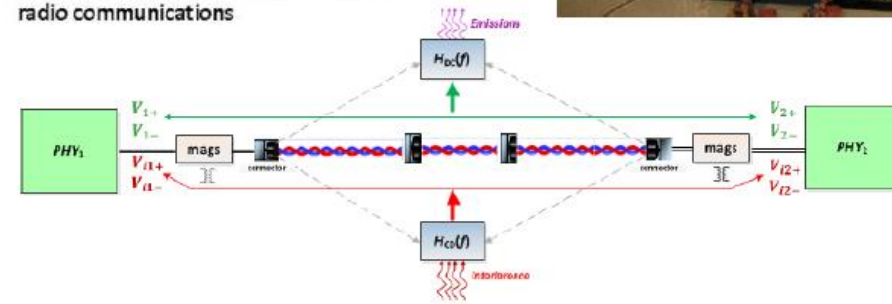
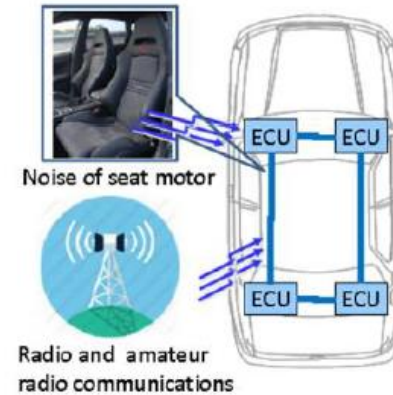


# Automotive Ethernet Signal Qualification

EMI/EMC Test

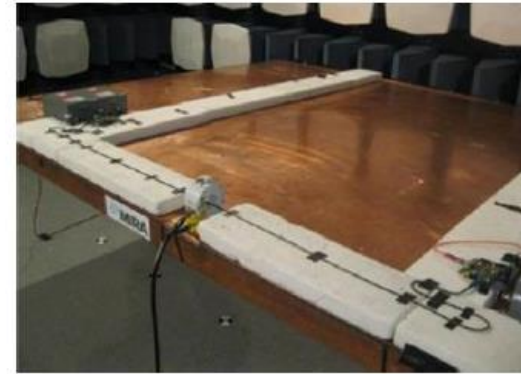
# Automotive Ethernet EMC Test

- EMC test requirements are not standardized
- Unbalanced impedance of ECU and cabling with cause common mode noise to interferes with data signal and cause malfunction of ECU electronics
- Bulk Current Injection Test (BCI ISO11452-4)
  - Used for component level testing (DUT, cable, connectors,
  - Interference is injected (1 MHz to 400 MHz) through the current injection clamp
  - Common Mode (CM) coupling to a differential pair channel
  - BCI test is widely used by automotive due to easy setup, repeatability and direct correlation to in-car noise models

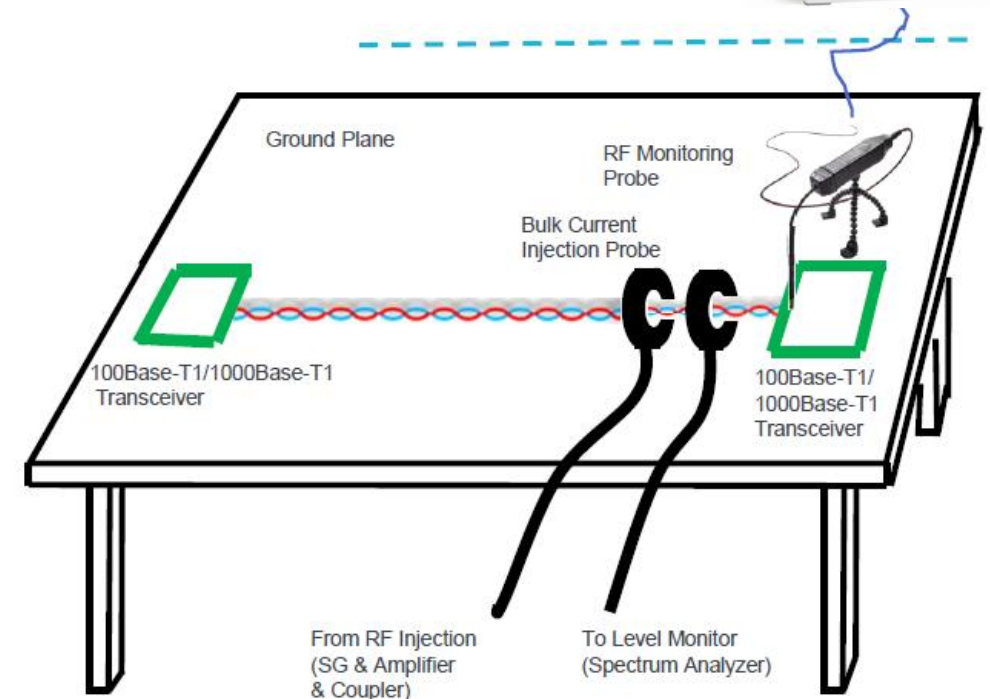
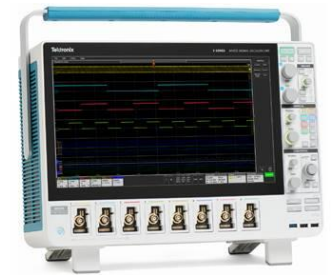


# Debug of BCI Immunity Test

- Measure actual voltage amplitude caused by RF Injection
- Check transceiver operates correctly under BCI injection of 1 MHz-400 MHz
- High CMRR performance of TIVM1L (IsoVu) is very effective
- Place oscilloscope outside of shield room



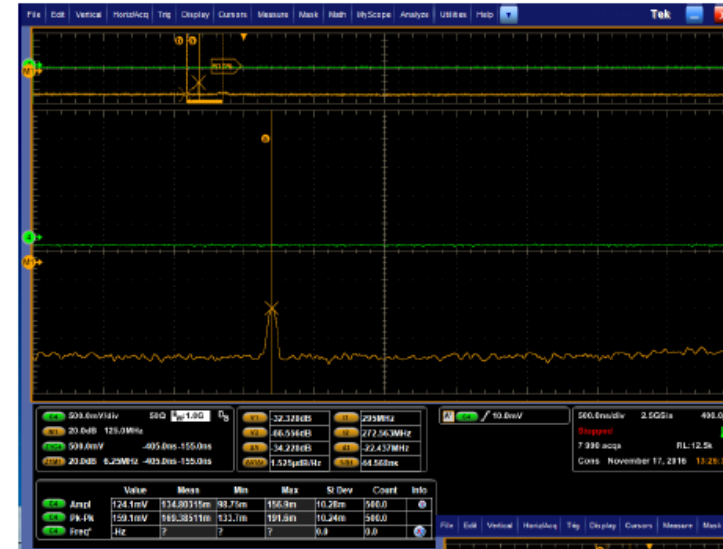
Scope outside test chamber



# BCI Test Result with IsoVu

- Evaluate probe susceptibility to EMI field from RF injection placed near DUT but floating
- Connect IsoVu to DUT to evaluate true signal and debug

Open Input (floating) with IsoVu



Near zero due to CMRR performance & shielding



IsoVu connected to receiver

Open Input with P6251

Poor CMRR performance showing band of noise



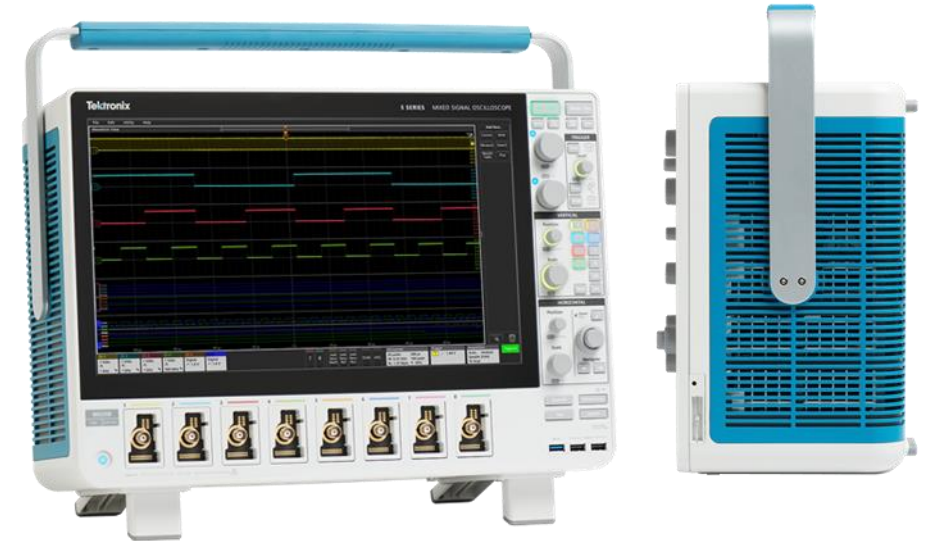
# Automotive Ethernet Testing

Tektronix Solutions

# Hardware Platform

THE MOST FLEXIBLE AND CAPABLE SCOPE FOR AUTOMOTIVE APPLICATIONS

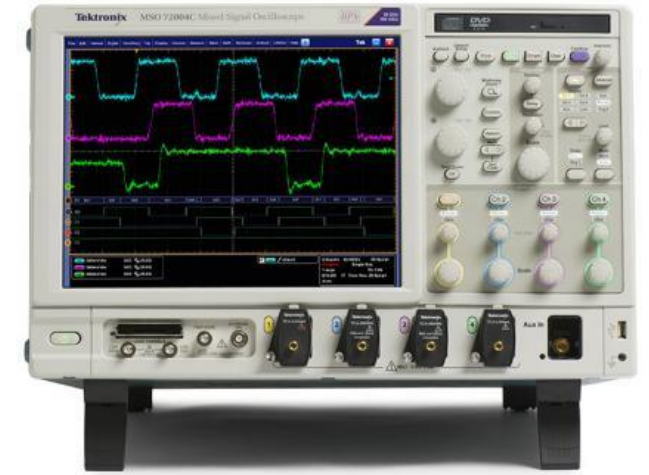
5 Series MSO	MSO54	MSO56	MSO58
Bandwidth	350 MHz, 500 MHz, 1 GHz, 2 GHz		
Maximum Analog Channels	4	6	8
Maximum Digital Channels (optional in 8 channel increments)	32	48	64
Sample Rate (all A&D ch.)	6.25 GS/s		
Standard Record Length (all A&D ch.)	62.5 M		
Max. Opt. Record Length (all A&D ch.)	125 M		
Waveform Capture Rate	500,000 wfms/s		
ADC Resolution	12 bits		
Vertical Resolution	8 bits at 6.25 GS/s 12 bits at 3.125 GS/s Up to 16 bits w/ High Res		
Arbitrary/Function Generator	Up to 50 MHz (opt.)		
Integrated DVM & Trigger Freq. Counter	Free with product registration		
Price Range	\$12,600 – \$40,600		



Oscilloscope  
Logic Analyzer  
Arbitrary/Function Generator  
Protocol Analyzer  
DVM  
Trigger Frequency Counter

# Hardware Platform

	MSO/DPO5000	DPO7000	MSO/DPO70000
Bandwidth	350 MHz-2 GHz	500 MHz-3.5 GHz	4GHz to 33GHz
Maximum Analog Channels		4 channels	
Maximum Digital Channels (optional)	16	-	16
Sample Rate	5 GS/s - 10 GS/s	5 GS/s - 40 GS/s	25 GS/s - 100 GS/s
Standard Record Length	25M	25M	25M
Max. Opt. Record Length	125M	500M	500M
Waveform Capture Rate	>250,000 wfms/s	>250,000 wfms/s	>300,000 wfms/s
ADC Resolution		8 bits	



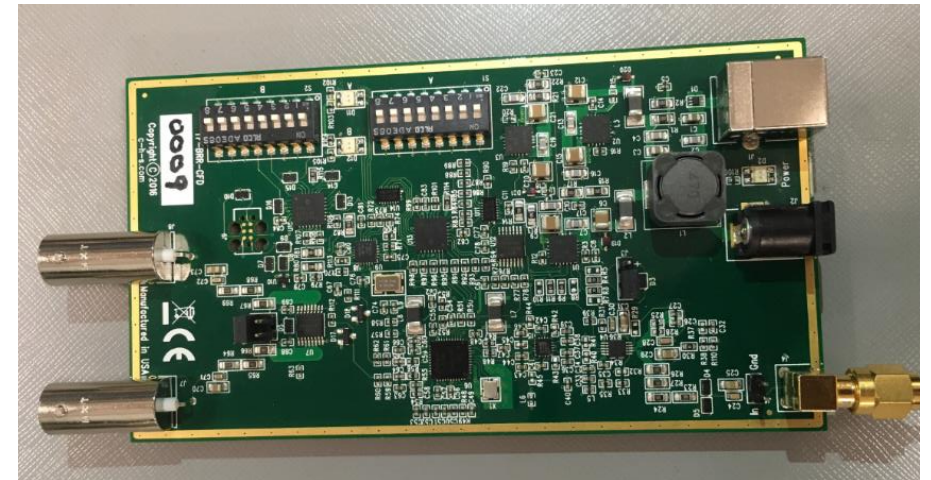
# Signal Access



TDP3500 Probe



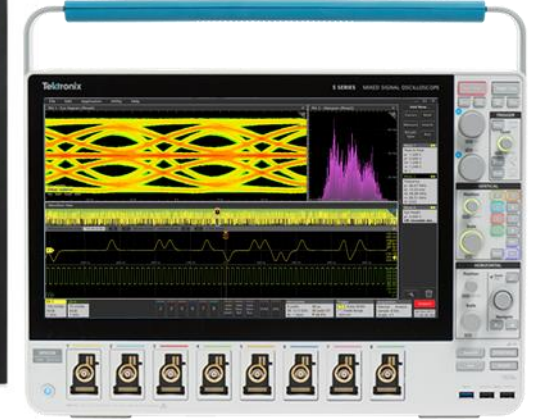
TF-XGbT Fixture



Clock Divider

# Automotive Ethernet Compliance Solution

- Oscilloscope: MSO 5 Series, MSO/DPO5KB, DPO7KC/70KC
  - 1 GHz minimum bandwidth (100BASET1)
  - 2GHz Minimum bandwidth (1000BASET1)
- Software:
  - 5-CMAUTOEN: 1000BASE-T1/100BASE-T1 compliance
  - Optional Advanced jitter software
  - Optional protocol decode
- Probes: TDP1500 (2 required)- 100BASET1  
TDP3500 (2 required)- 1000BASET1
- Signal source: AFG3152C- 100BASET1,  
AWG5200-1000BASET1 or VNA



Scope	Scope Options	Probes	Fixture 1	Fixture 2	Source
5 Series	2 GHz bandwidth, Windows, 5-SR AUTO, 5-DJA, 5-CMAUTOEN	TDP1500 Or TDP3500	TF-XGbT	TF-BRR-CFD or SW clk recovery	AFG3152C
DPO5K/7K/70K	> 2 GHz bandwidth, BRR, DJA, SR-AUTO	TDP1500 Or TDP3500 (VPI Connector)	TF-XGbT	TF-BRR-CFD or SW clk recovery	AFG3152C

# What's coming up

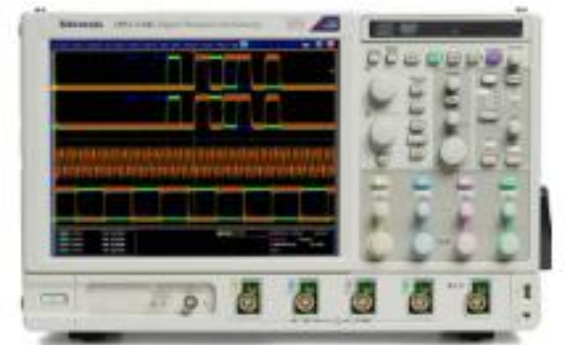
- VNA support for Return Loss and MDI Mode conversion Loss measurement
- Software Clock Recovery for 1000BASE-T1 Distortion measurement
- SMA Cable support
- Multiple Run: Configure specific measurement to run N times
- PAM3 Analysis (Eye Diagram, Rise time Measurement etc.)

# Why Tektronix

- Ease of use: Complete Automated measurements with Pass/Fail Report
- Signal Qualification: Powerful Debug and Validation using DPOJET, Run measurement in continues mode for Signal quality test under different voltage, Temperature and noise environment.
- Multipurpose Instrument: Return loss using proven, patented scope-based measurement
- Complete Portfolio for Automotive: Tektronix offers EMI/EMC, ESD, BCI, Power Measurement, High Speed standards like DDR, PCIe, USB, MIPI, LVDS etc compliance solution for Automotive Applications.
- Future Proof: Tektronix is actively working on future Automotive Ethernet standards (Contact Tektronix representative for more info)

# In-Vehicle Network Portfolio

Platform	Standards supported	Measurements supported	Advantage
MDO3000 MDO4000C	CAN, CAN-FD, LIN, FlexRay	Protocol, Signal Qualification, EMI/EMC, ESD Test, Power Measurement	4 Analog Channel, 16 Logic channel, Dedicated Spectrum Analyzer
5 Series MSO	CAN, CAN-FD, LIN, FlexRay, SENT, 100BASE-T1, 1000BASE-T1	Protocol, Compliance, Signal Qualification, ESD test, Power Measurement	8 Analog Channel, 64 Logic channel, 12 bit ADC
MSO/DPO5000B DPO7000C MSO/DPO70000	CAN, LIN, FlexRay, 100BASE-T1, 1000BASE-T1	Protocol, Compliance, Signal Qualification, ESD test, Power Measurement	4 Analog channel, 16 logic channel, 2GHz to 70GHz, supports high speed standards like DDR, PCIe, MIPI, USB, 10G Ethernet, HDMI, DP, Flash memory etc.



# Automotive Reference

- Automotive website: [www.tek.com/automotive](http://www.tek.com/automotive)
- Automotive Ethernet: [www.tek.com/automotive/automotive-ethernet](http://www.tek.com/automotive/automotive-ethernet)
- Automotive Power: [www.tek.com/power-efficiency/market-your-power-conversion-designs](http://www.tek.com/power-efficiency/market-your-power-conversion-designs)
- EMI/EMC: [www.tek.com/application/electromagnetic-interference-emi-and-electromagnetic-compatibility-emc](http://www.tek.com/application/electromagnetic-interference-emi-and-electromagnetic-compatibility-emc)

# Tektronix

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Thank you!

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